



Full

TEST REPORT

No. I15D00057-RFB

For

Client : Ingram Micro Chile S.A

Production : Smartphone

Model Name : S4040

FCC ID: 2AELAS4040

Hardware Version: V04

Software Version: V01

Issued date: 2015-05-20

Note:

The test results in this test report relate only to the devices specified in this report. This report shall not be reproduced except in full without the written approval of ECIT Shanghai.

Test Laboratory:

ECIT Shanghai, East China Institute of Telecommunications

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**Revision Version**

Report Number	Revision	Date	Memo
I15D00057-RFB	00	2015-05-20	Initial creation of test report

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1. Test Laboratory

1.1. Testing Location

Company Name:	ECIT Shanghai, East China Institute of Telecommunications
Address:	7-8F, G Area, No. 668, Beijing East Road, Huangpu District, Shanghai, P. R. China
Postal Code:	200001
Telephone:	(+86)-021-63843300
Fax:	(+86)-021-63843301

1.2. Testing Environment

Normal Temperature:	15-35°C
Extreme Temperature:	-10/+55°C
Relative Humidity:	20-75%

1.3. Project data

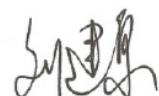
Project Leader:	Wang Yaqiong
Testing Start Date:	2015-04-16
Testing End Date:	2015-05-09

1.4. Signature



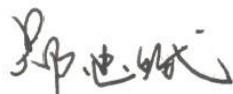
Wang Daming

(Prepared this test report)



Liu Jianquan

(Reviewed this test report)



Zheng Zhongbin

Director of the laboratory

(Approved this test report)

2. Client Information

2.1. Applicant Information

Company Name: Ingram Micro Chile S.A
Address: El Rosal,4765,Huechuraba,Santiago,CL
Telephone: +56961702958
Postcode: 6582412

2.2. Manufacturer Information

Company Name: MOBIWIRE MOBILES (NINGBO) CO.,LTD
Address: No.999,Dacheng East Road,Fenghua City,Zhejiang
Telephone: +86-0574-88916450
Postcode: 315500

3. Equipment Under Test (EUT) and Ancillary Equipment (AE)

3.1. About EUT

EUT Description	Smartphone
Model name	S4040
GSM Frequency Band	GSM850/900/1800/1900
Bluetooth Frequency	2402MHz-2480Mhz
Bluetooth Channel	Channel0-Channel78
Bluetooth Modulation	GMSK; $\pi/4$ DQPSK;8DPSK
Extreme Temperature	-10/+55°C
Nominal Voltage	3.8V
Extreme High Voltage	4.35V
Extreme Low Voltage	3.6V

Note: Photographs of EUT are shown in ANNEX A of this test report.

3.2. Internal Identification of EUT used during the test

EUT ID*	SN or IMEI	HW Version	SW Version	Date of receipt
N09	354648020000251	V04	V01	2015-04-15

*EUT ID: is used to identify the test sample in the lab internally.

3.3. Internal Identification of AE used during the test

AE ID*	Description	SN
AE1	RF cable	---
AE2	---	---

*AE ID: is used to identify the test sample in the lab internally.

4. Reference Documents

4.1. Reference Documents for testing

The following documents listed in this section are referred for testing.

Reference	Title	Version
FCC Part15	FCC CFR 47, Part 15,Subpart C: 15.205 Restricted bands of operation; 15.209 Radiated emission limits, general requirements; 15.247 Operation within the bands 902-928MHz, 2400-2483.5MHz, and 5725-5850MHz.	Oct,2009 Edition
ANSI C63.10	American National Standard of Procedures for Compliance Testing of Unlicensed Wireless Devices	2009

5. Summary of Test Results

A brief summary of the tests carried out is shown as following.

Measurement Items	Sub-clause of Part15C	Sub-clause of IC	Verdict
Maximum Peak Output Power	15.247(b)	/	P
Peak Power Spectral Density	15.247(d)	/	NA
20dB Occupied Bandwidth	15.247(a)	/	P
Band Edges Compliance	15.247(b)	/	P
Transmitter Spurious Emission-Conducted	15.247	/	P
Transmitter Spurious Emission-Radiated	15.247,15.209,	/	P
AC Powerline Conducted Emission	15.107,15.207	/	P

Please refer to part 5 for detail.

The measurements are according ANSI C63.10.

Terms used in Verdict column

P	Pass, the EUT complies with the essential requirements in the standard.
NP	Not Perform, the test was not performed by ECIT.
NA	Not Applicable, the test was not applicable.
F	Fail, the EUT does not comply with the essential requirements in the standard.

Test Conditions

T _{nom}	Normal Temperature
T _{min}	Low Temperature
T _{max}	High Temperature
V _{nom}	Normal Voltage
V _{min}	Low Voltage
V _{max}	High Voltage
H _{nom}	Norm Humidity
A _{nom}	Norm Air Pressure

For this report, all the test case listed above are tested under Normal Temperature and Normal Voltage, and also under norm humidity, the specific conditions as following:

Temperature	T _{nom}	22°C
Voltage	V _{nom}	3.8V
Humidity	H _{nom}	32%
Air Pressure	A _{nom}	1010hPa

Note:

- a. All the test data for each data were verified, but only the worst case was reported.
- b. The GFSK, $\pi/4$ DQPSK and 8DPSK were set in DH1 for GFSK, 2-DH1 for $\pi/4$ DQPSK, 3-DH1 for 8DPSK.
- c. The DC and low frequency voltages' measurement uncertainty is $\pm 2\%$.

5.1. Notes

All reported tests were carried out on a sample equipment to demonstrate limited compliance with section 3.

The test results of this test report relate exclusively to the item(s) tested as specified in section 5.

The following deviation from, additions to, or exclusions from the test specifications have been made. See section 3.

5.2. Statements

The product name S4040, supporting
GSM/GPRS/WLAN/BT/WCDMA/HSDPA/HSUPA/HSPA+, manufactured by MOBIWIRE
MOBILES (NINGBO) CO.,LTD is a new product for testing.

ECIT has verified that the compliance of the tested device specified in section 5 of this test report is successfully evaluated according to the procedure and test methods as defined in type certification requirement listed in section 5 of this test report.

6. Test result

6.1. Peak Output Power-Conducted

6.1.1 Measurement Limit

Standard	Limit (dBm)
FCC Part 15.247(b)(1)	< 30

6.1.2 Test Condition:

Hopping Mode	RBW	VBW	Span	Sweeptime
Hopping OFF	3MHz	10MHz	9MHz	Auto

6.1.3 Test procedure

The measurement is according to ANSI C63.10 clause 6.10.1

1. The output power of EUT was connected to the spectrum analyzer and CBT32 by cable and divide. The path loss was compensated to the results for each measurement.
2. Enable EUT transmitter maximum power continuously.
3. Measure the conducted output power and record the results it.

6.1.4 Measurement Results:

For GFSK

Channel	Ch0 2402 MHz	Ch39 2441 MHz	CH78 2480 MHz	Conclusion
Peak Conducted Output Power (dBm)	2.085	2.199	2.092	P
	Fig.1	Fig.2	Fig.3	

For π/4 DQPSK

Channel	Ch0 2402 MHz	Ch39 2441 MHz	CH78 2480 MHz	Conclusion
Peak Conducted Output Power (dBm)	1.291	1.383	1.154	P
	Fig.4	Fig.5	Fig.6	

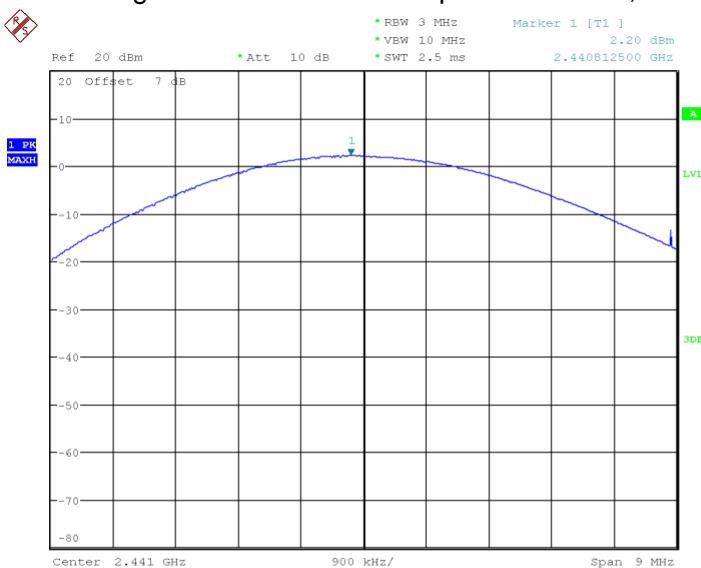
For 8DPSK

Channel	Ch0 2402 MHz	Ch39 2441 MHz	CH78 2480 MHz	Conclusion

Peak Conducted Output Power (dBm)	1.299	1.357	1.154	P
	Fig.7	Fig.8	Fig.9	

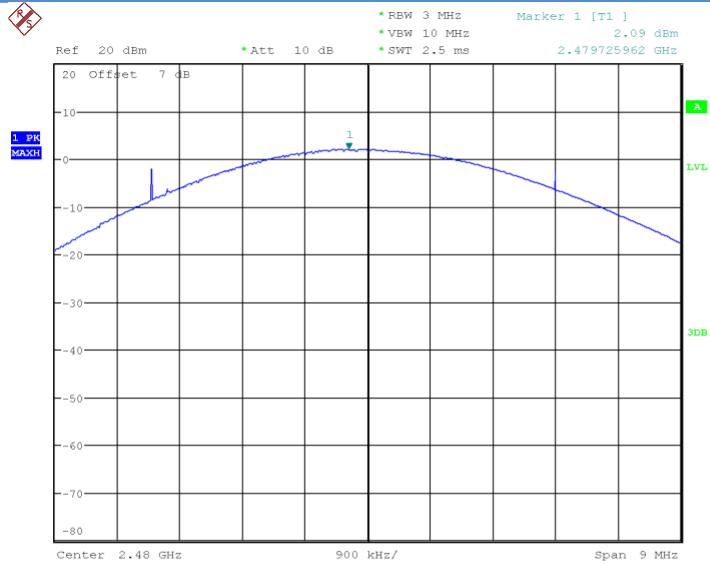
Conclusion: PASS
Test graphs an below


Date: 24.APR.2015 14:41:21

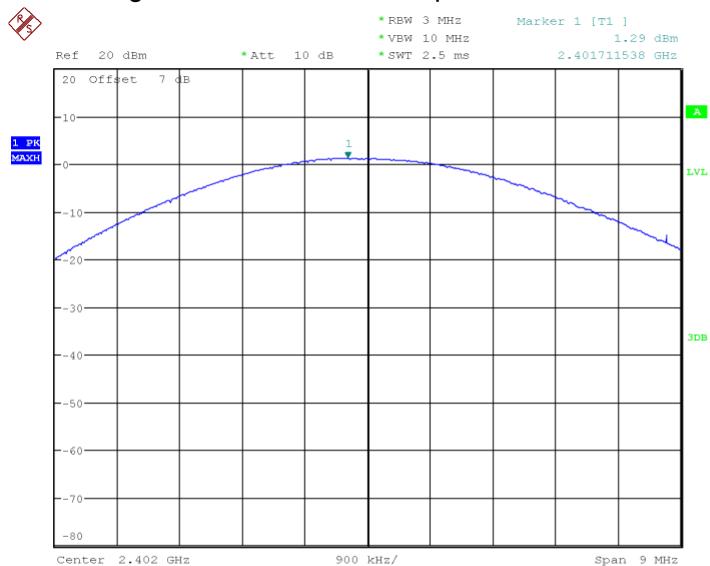
Fig.1 Peak Conducted Output Power CH0, DH1


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Fig.2 Peak Conducted Output Power CH39, DH1

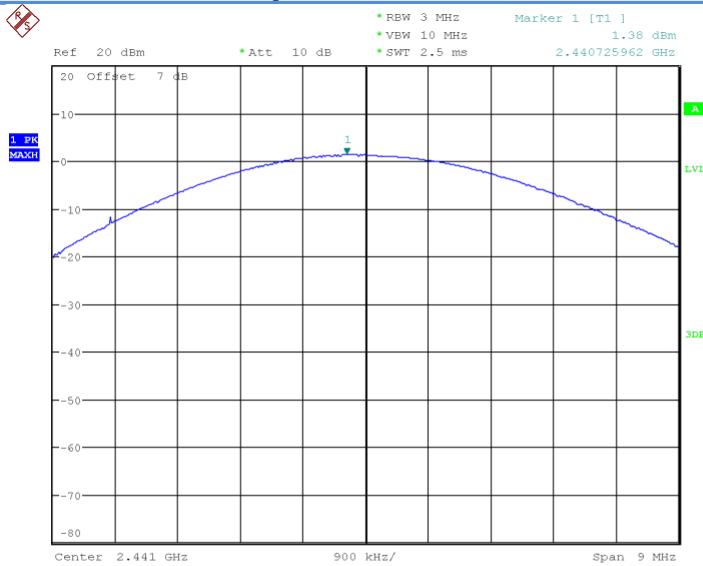


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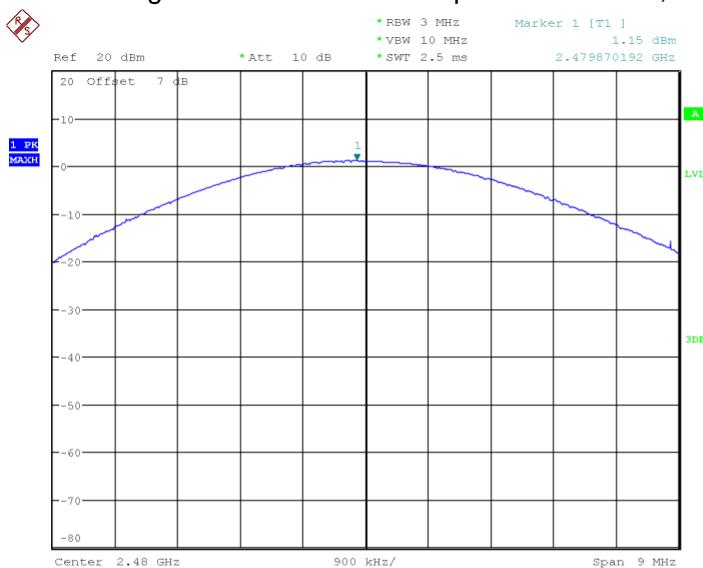
Fig.3 Peak Conducted Output Power CH78, DH1


Date: 24.APR.2015 14:41:58

Fig.4 Peak Conducted Output Power CH0, 2DH1

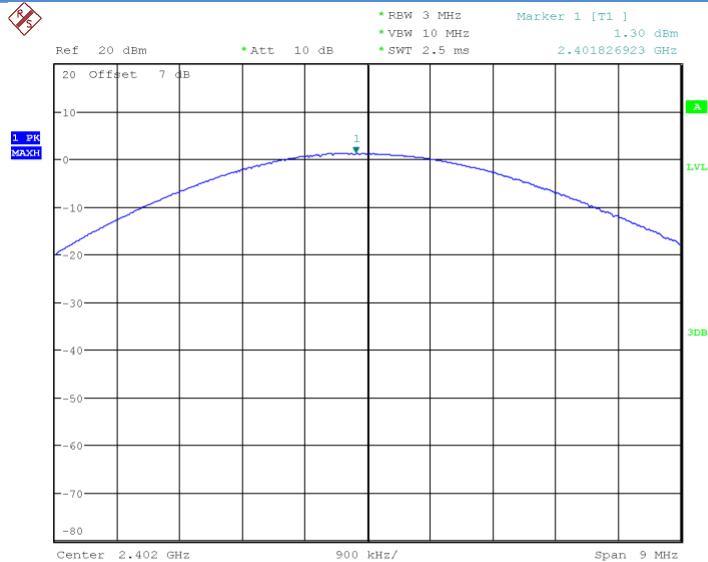


Date: 24.APR.2015 14:42:11

Fig.5 Peak Conducted Output Power CH39, 2DH1


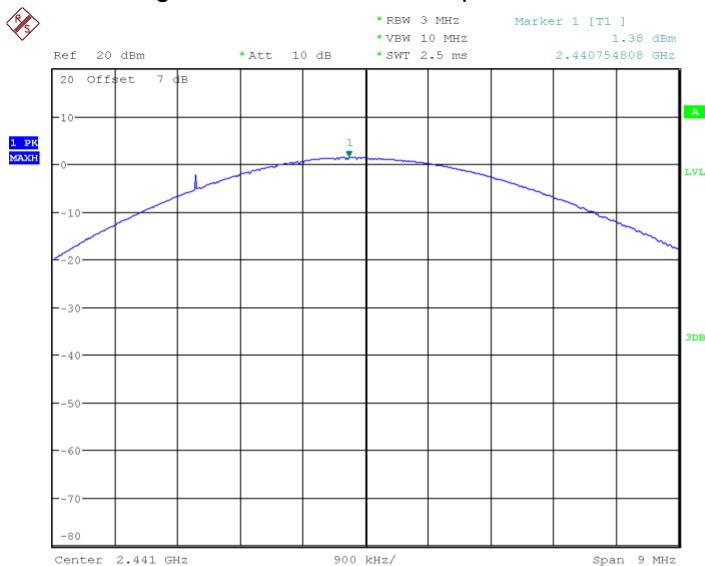
Date: 24.APR.2015 14:42:23

Fig.6 Peak Conducted Output Power CH78, 2DH1



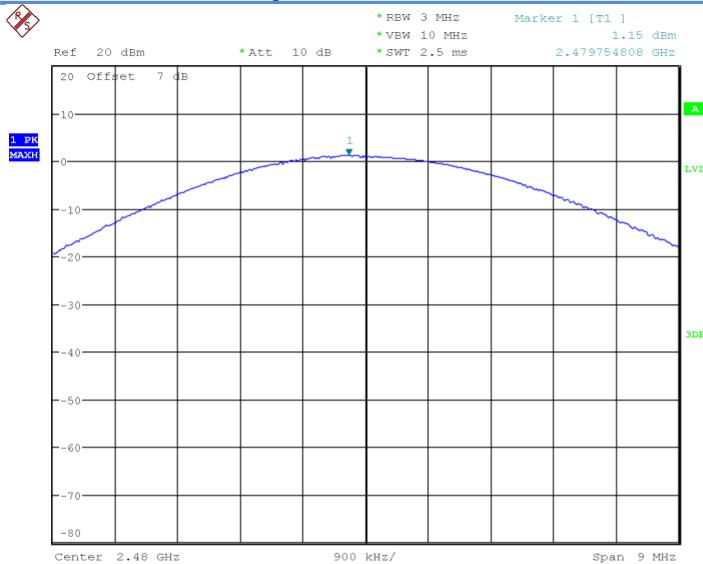
Date: 24.APR.2015 14:42:36

Fig.7 Peak Conducted Output Power CH0, 3DH1



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Fig.8 Peak Conducted Output Power CH39, 3DH1



Date: 24.APR.2015 14:43:00

Fig.9 Peak Conducted Output Power CH78, 3DH1

6.2 Frequency Band Edges-Conducted

6.2.1 Measurement Limit:

Standard	Limited(dBc)
FCC 47 CFR Part 15.247(d)	>20

6.2.2 Test procedure

The measurement is according to ANSI C63.10 clause 6.9.2.

1. Connect the EUT to spectrum analyzer.
2. Set RBW=100KHz, VBW=300KHz, span more than 1.5 times channel bandwidth (2MHz).
3. Detector =peak, sweep time=auto couple, trace mode=max hold.
4. Allow sweep to continue until the trace stabilizes.

6.2.3 Measurement results

For GFSK

Channel	Hopping	Band Edge Power (dBc)	Conclusion
0	Hopping OFF	Fig.10	P
	Hopping ON	Fig.11	P
78	Hopping OFF	Fig.12	P

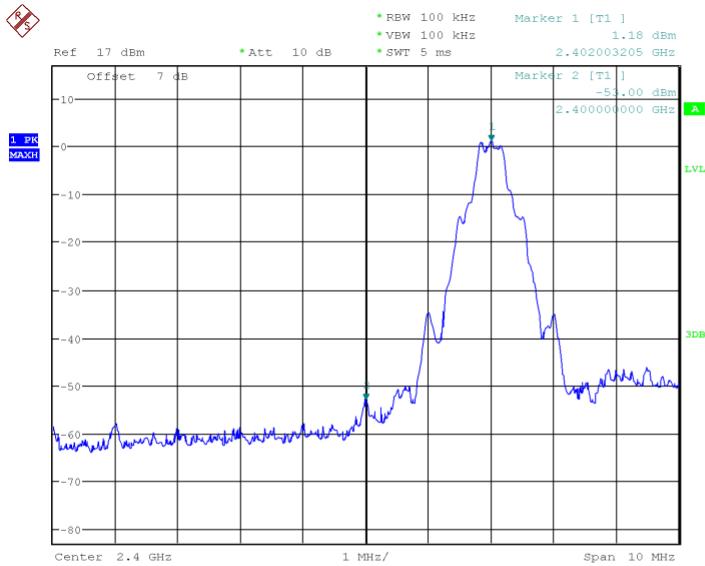
	Hopping ON	Fig.13	P
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For $\pi/4$ DQPSK

Channel	Hopping	Band Edge Power (dBc)	Conclusion
0	Hopping OFF	Fig.14	P
	Hopping ON	Fig.15	P
78	Hopping OFF	Fig.16	P
	Hopping ON	Fig.17	P

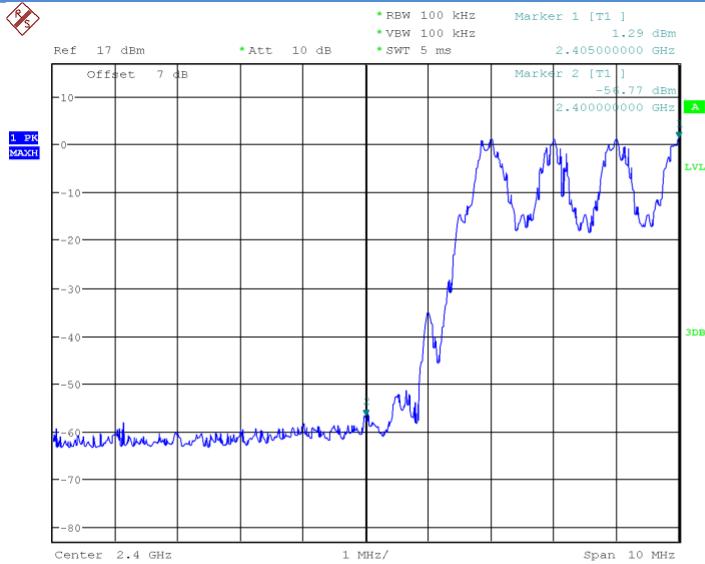
For 8DPSK

Channel	Hopping	Band Edge Power (dBc)	Conclusion
0	Hopping OFF	Fig.18	P
	Hopping ON	Fig.19	P
78	Hopping OFF	Fig.20	P
	Hopping ON	Fig.21	P

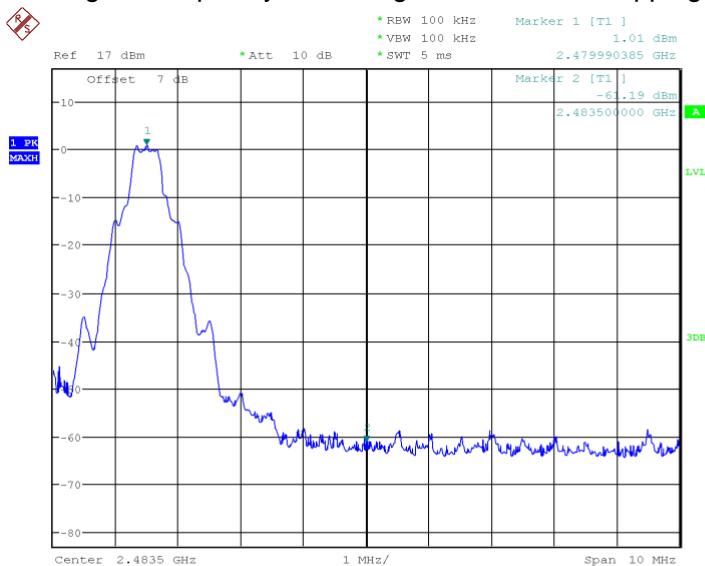
Conclusion: PASS
Test graphs are below


Date: 24.APR.2015 15:37:03

Fig.10 Frequency Band Edge: GFSK, Ch0, Hopping OFF

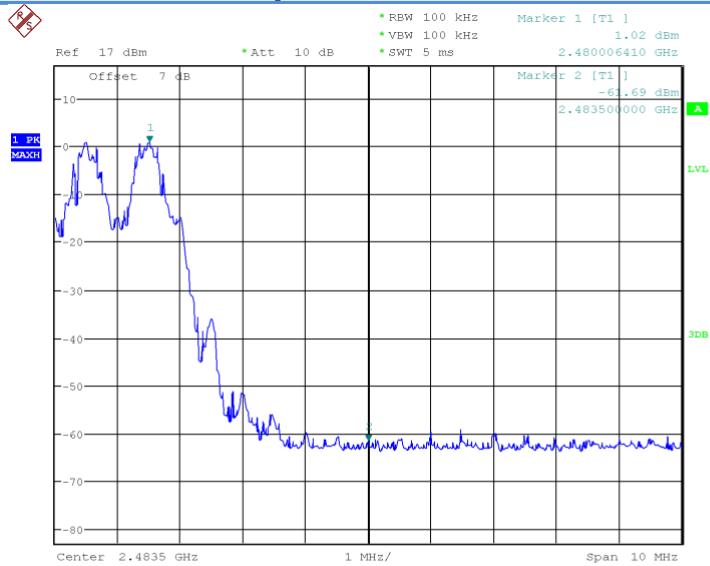


Date: 24.APR.2015 15:39:07

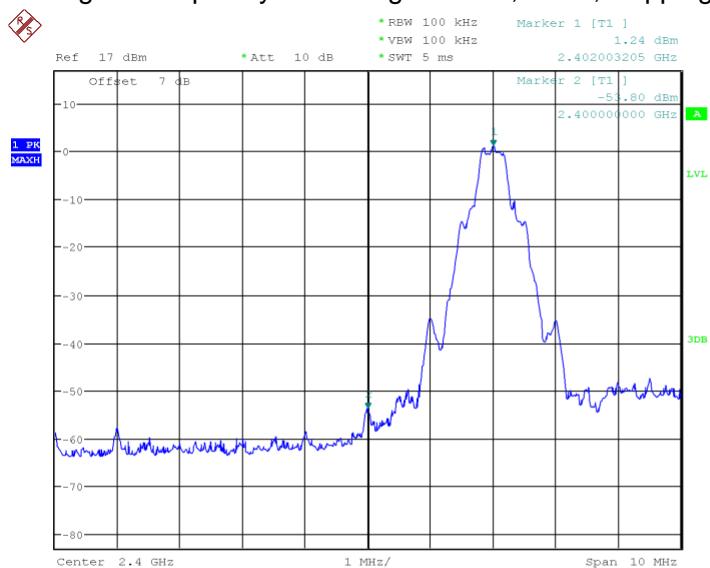
Fig.11 Frequency Band Edge: GFSK, Ch0, Hopping ON


Date: 24.APR.2015 15:45:02

Fig.12 Frequency Band Edge: GFSK, Ch78, Hopping OFF

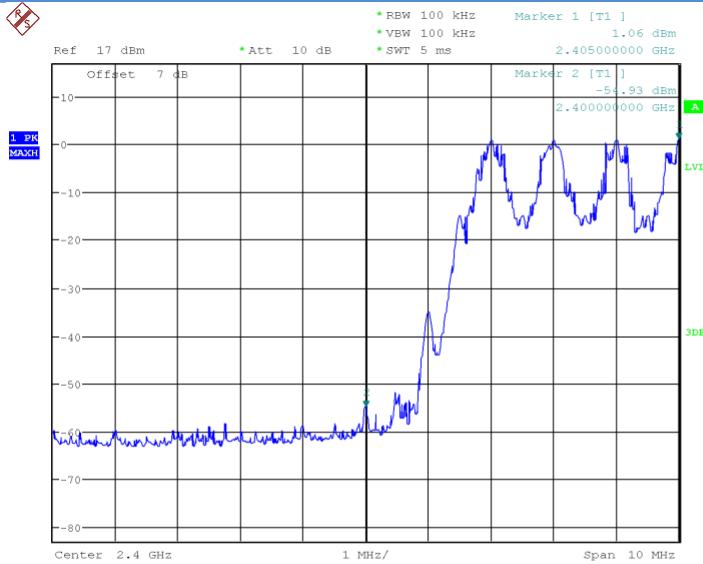


Date: 24.APR.2015 15:47:06

Fig.13 Frequency Band Edge: GFSK, Ch78, Hopping ON


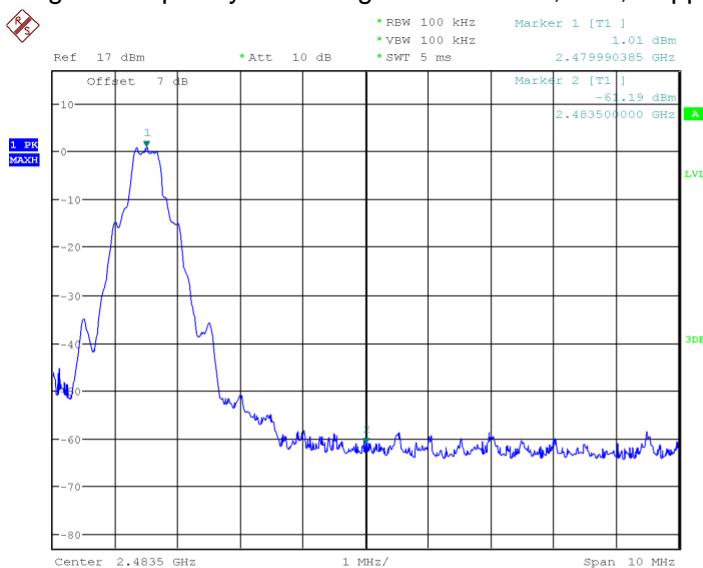
Date: 24.APR.2015 15:42:21

Fig.14 Frequency Band Edge: $\pi/4$ DQPSK, Ch0, Hopping OFF



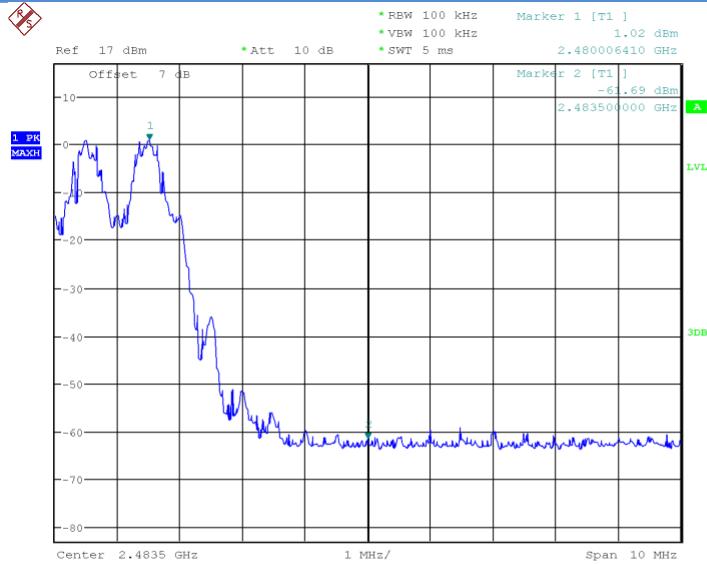
Date: 24.APR.2015 15:44:26

Fig.15 Frequency Band Edge: $\pi/4$ DQPSK, Ch0, Hopping ON

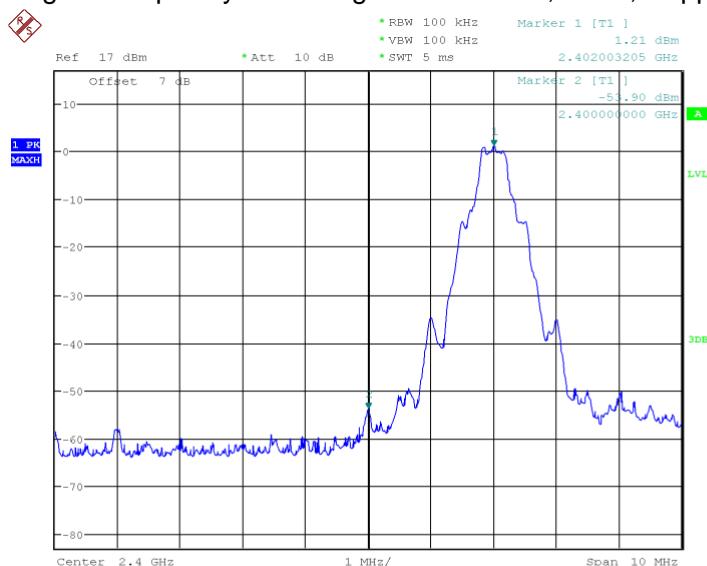


Date: 24.APR.2015 15:45:02

Fig.16 Frequency Band Edge: $\pi/4$ DQPSK, Ch78, Hopping OFF



Date: 24.APR.2015 15:47:06

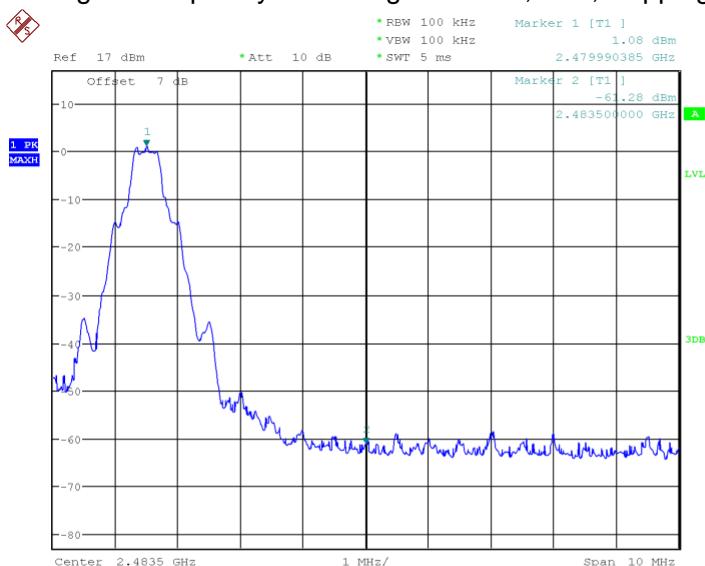
Fig.17 Frequency Band Edge: $\pi/4$ DQPSK, Ch78, Hopping ON


Date: 24.APR.2015 15:39:42

Fig.18 Frequency Band Edge: 8DPSK, Ch0, Hopping OFF

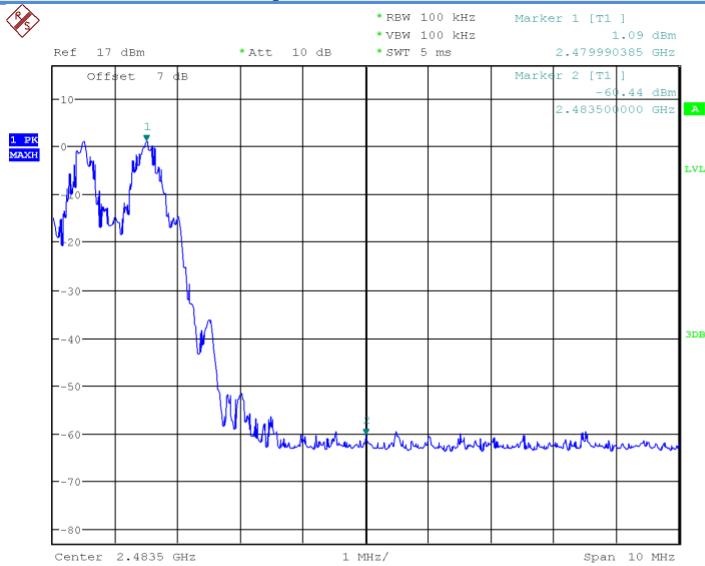


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Fig.19 Frequency Band Edge: 8DPSK, Ch0, Hopping ON


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Fig.20 Frequency Band Edge: 8DPSK, Ch78, Hopping OFF



Date: 24.APR.2015 15:52:25

Fig.21 Frequency Band Edge: 8DPSK, Ch78, Hopping ON

6.3 Conducted Emission

6.3.1 Measurement Limit:

Standard	Limit
FCC 47 CFR Part15.247 (d)	20dB below peak output power in 100KHz bandwidth

6.3.2 Test procedures

The measurement is according to ANSI C63.10 clause 6.5, 6.6, 7.7.9, 7.7.10.

1. Connect the EUT to spectrum analyzer.
2. Set RBW=100KHz, VBW=300KHz.
3. Detector =peak, sweep time=auto couple, trace mode=max hold.

6.3.3 Measurement Results:

For GFSK

Channel	Frequency Range	Test Results	Conclusion
Ch0 2402MHz	Center Freq.	Fig.22	P
	30MHz~26GHz	Fig.23	P
Ch39 2441MHz	Center Freq.	Fig.24	P
	30MHz~26GHz	Fig.25	P
Ch78 2480MHz	Center Freq.	Fig.26	P



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	30MHz~26GHz	Fig.27	P
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For $\pi/4$ DQPSK

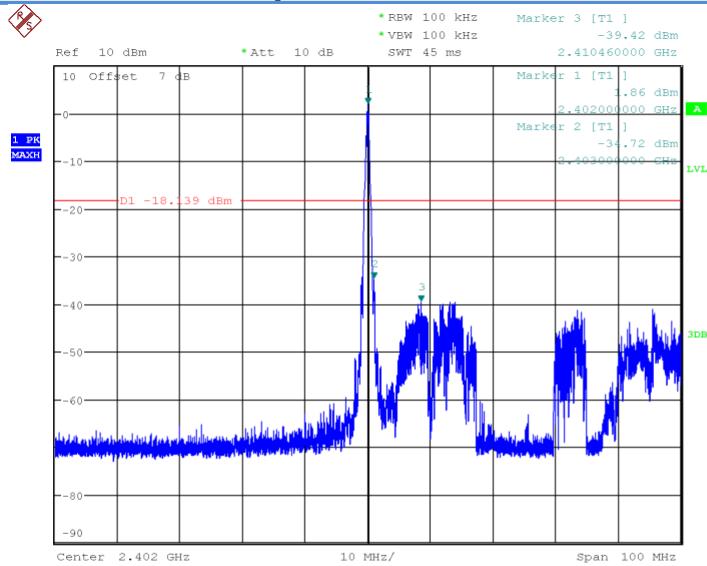
Channel	Frequency Range	Test Results	Conclusion
Ch0 2402MHz	Center Freq.	Fig.28	P
	30MHz~26GHz	Fig.29	P
Ch39 2441MHz	Center Freq.	Fig.30	P
	30MHz~26GHz	Fig.31	P
Ch78 2480MHz	Center Freq.	Fig.32	P
	30MHz~26GHz	Fig.33	P

For 8DPSK

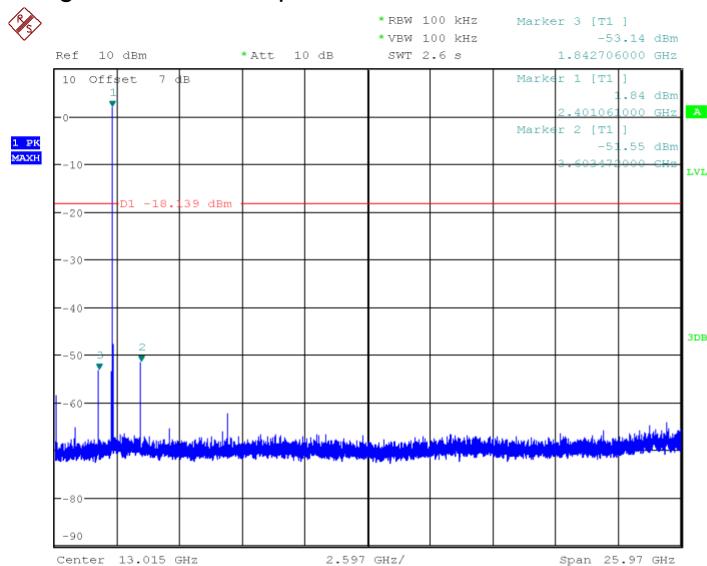
Channel	Frequency Range	Test Results	Conclusion
Ch0 2402MHz	Center Freq.	Fig.34	P
	30MHz~26GHz	Fig.35	P
Ch39 2441MHz	Center Freq.	Fig.36	P
	30MHz~26GHz	Fig.37	P
Ch78 2480MHz	Center Freq.	Fig.38	P
	30MHz~26GHz	Fig.39	P

Conclusion: PASS

Test graphs as below

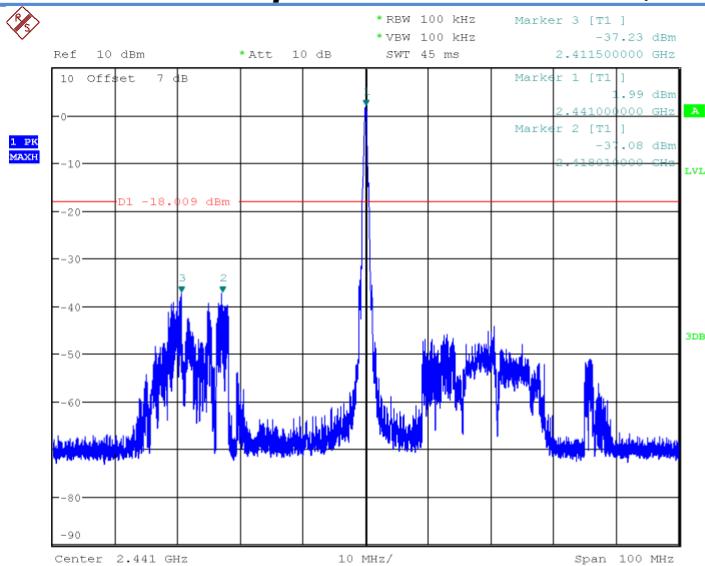


Date: 5.MAY.2015 14:42:15

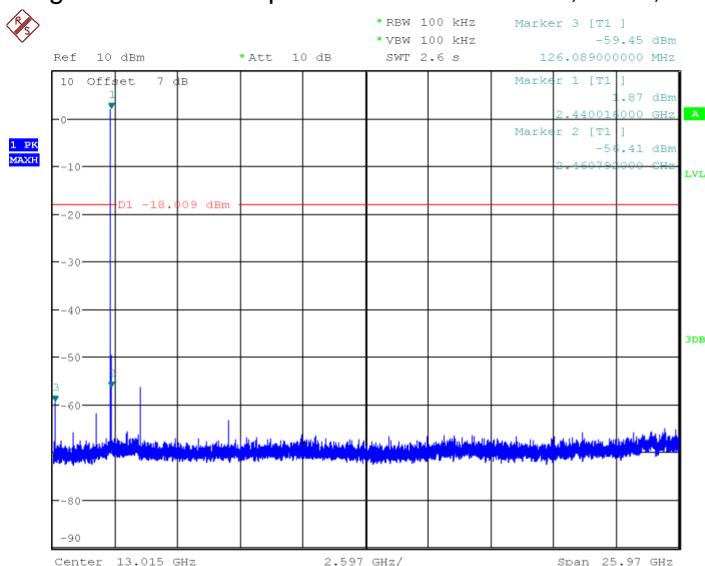
Fig.22 Conducted spurious emission: GFSK, Ch0, 2402MHz


Date: 5.MAY.2015 14:42:38

Fig.23 Conducted spurious emission: GFSK, Ch0, 30MHz~26GHz

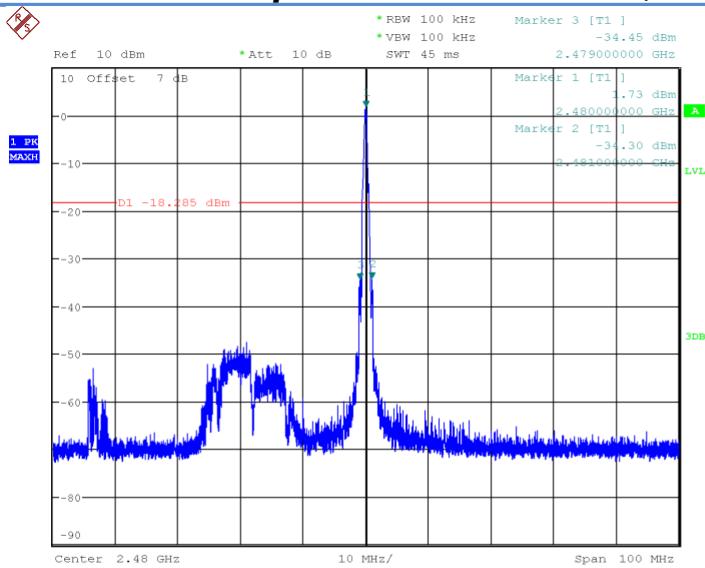


Date: 5.MAY.2015 14:43:02

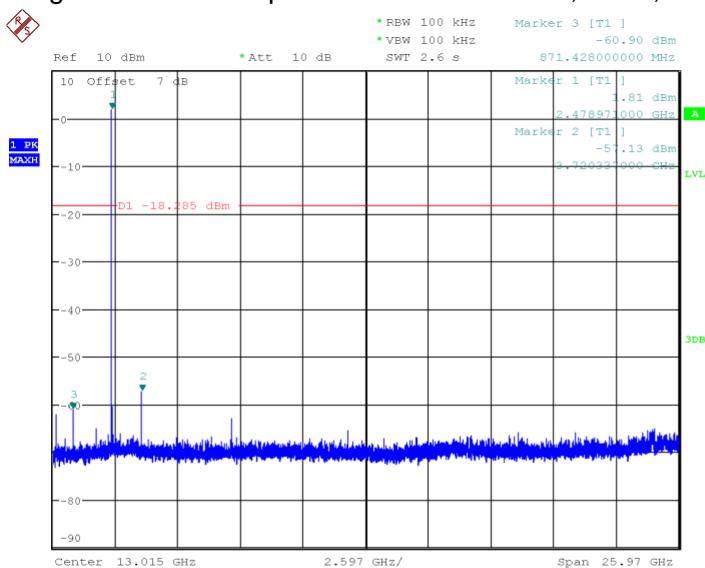
Fig.24 Conducted spurious emission: GFSK, Ch39, 2441MHz


Date: 5.MAY.2015 14:43:25

Fig.25 Conducted spurious emission: GFSK, Ch39, 30MHz~26GHz

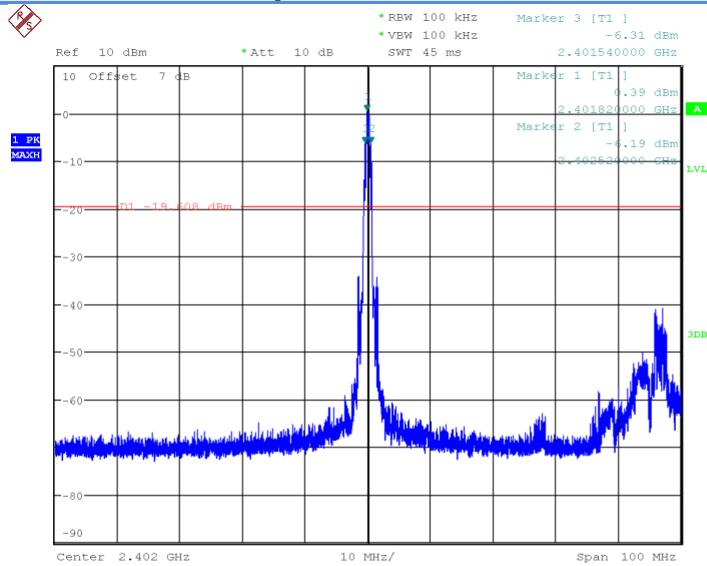


Date: 5.MAY.2015 14:43:50

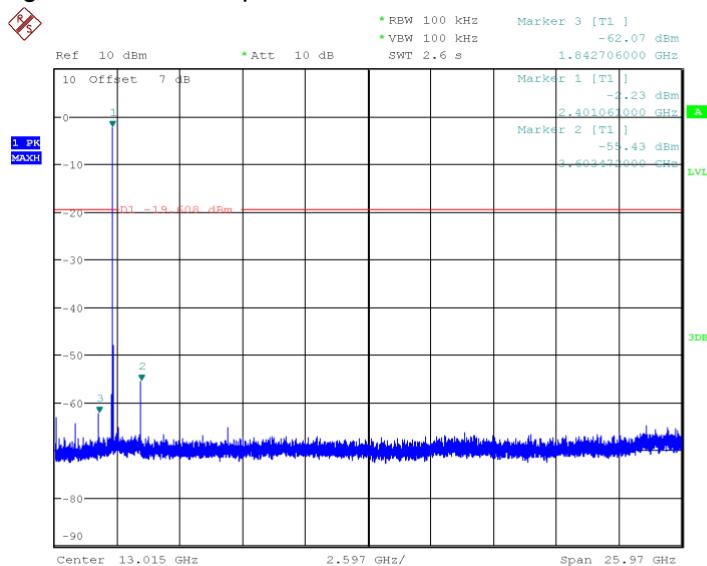
Fig.26 Conducted spurious emission: GFSK, Ch78, 2480MHz


Date: 5.MAY.2015 14:44:13

Fig.27 Conducted spurious emission: GFSK, Ch78, 30MHz~26GHz

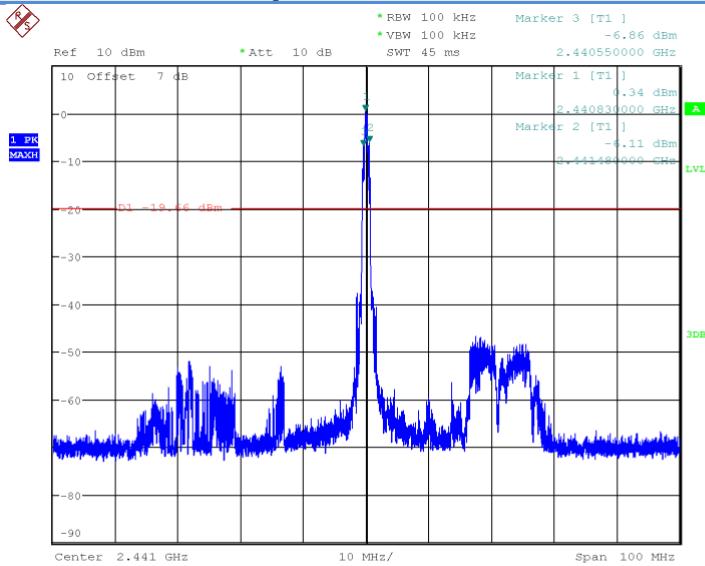


Date: 5.MAY.2015 14:44:38

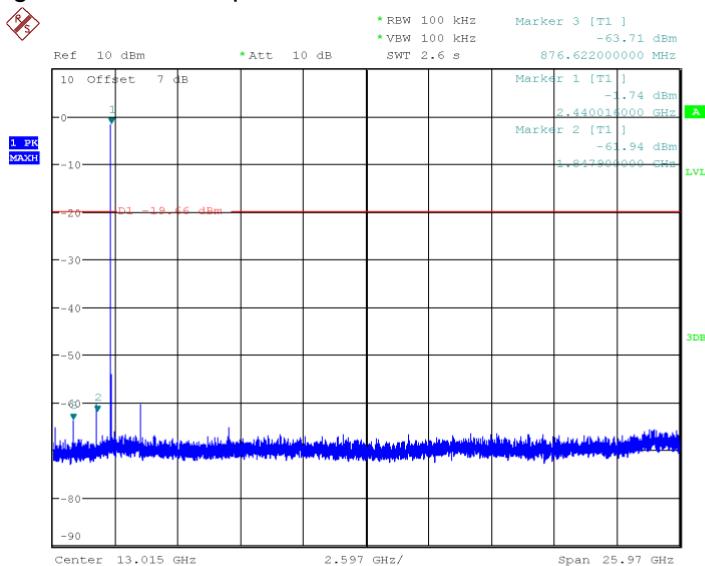
Fig.28 Conducted spurious emission: π/4 DQPSK, Ch0, 2402MHz


Date: 5.MAY.2015 14:45:01

Fig.29 Conducted spurious emission: π/4 DQPSK, Ch0, 30MHz~26GHz

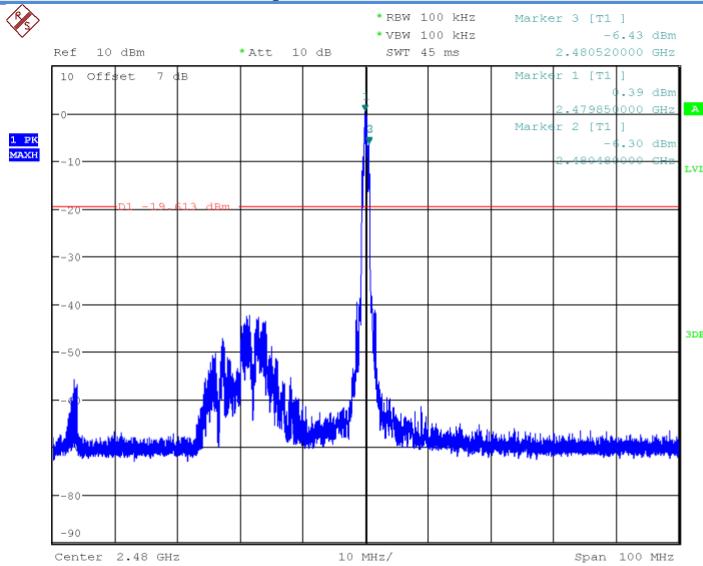


Date: 5.MAY.2015 14:45:26

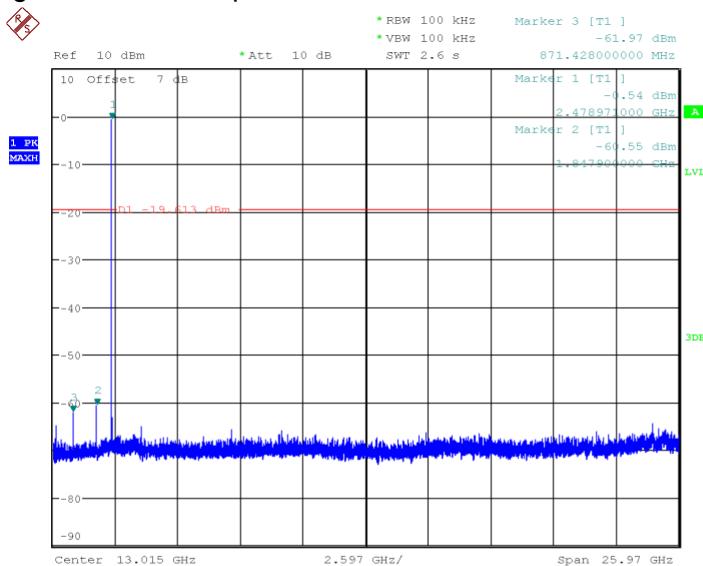
Fig.30 Conducted spurious emission: $\pi/4$ DQPSK, Ch39, 2441MHz


Date: 5.MAY.2015 14:45:49

Fig.31 Conducted spurious emission: $\pi/4$ DQPSK, Ch39, 30MHz~26GHz

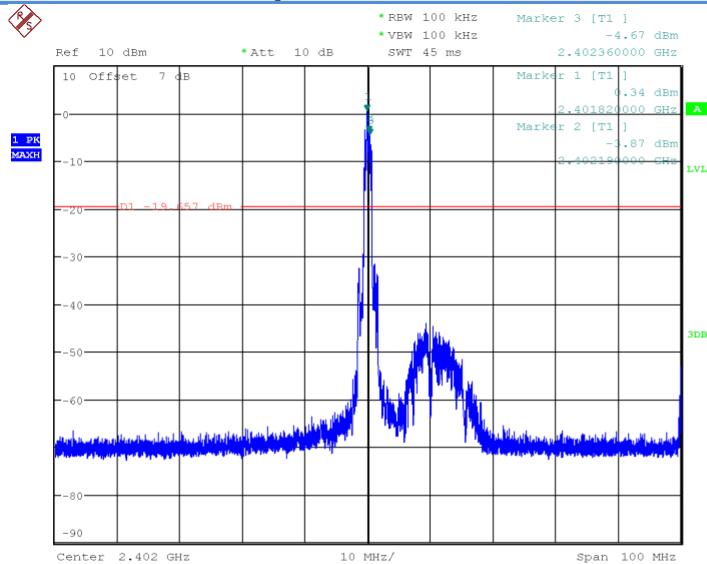


Date: 5.MAY.2015 14:46:13

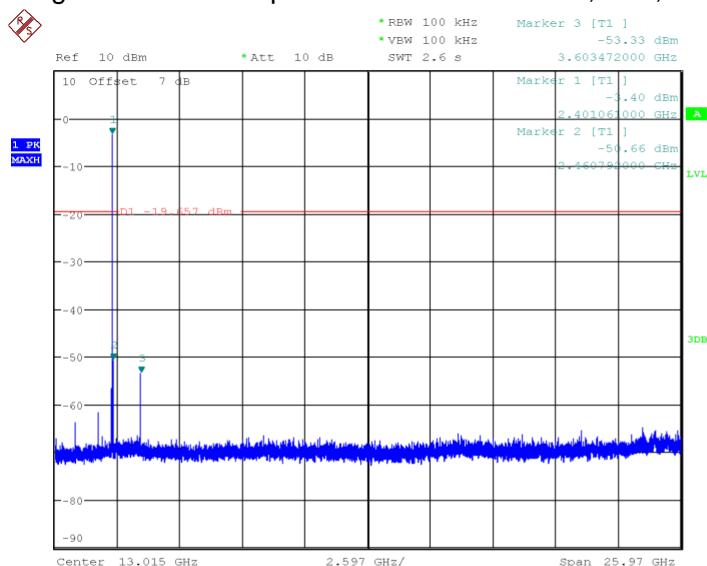
Fig.32 Conducted spurious emission: $\pi/4$ DQPSK, Ch78, 2480MHz


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Fig.33 Conducted spurious emission: $\pi/4$ DQPSK, Ch78, 30MHz~26GHz

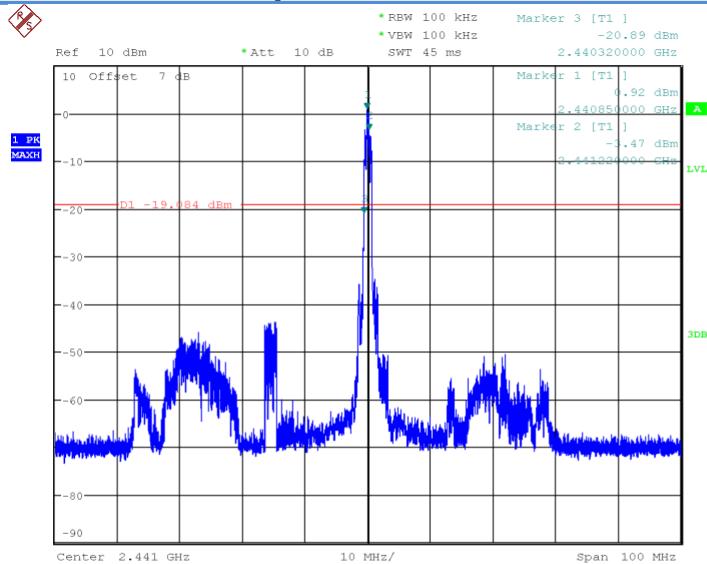


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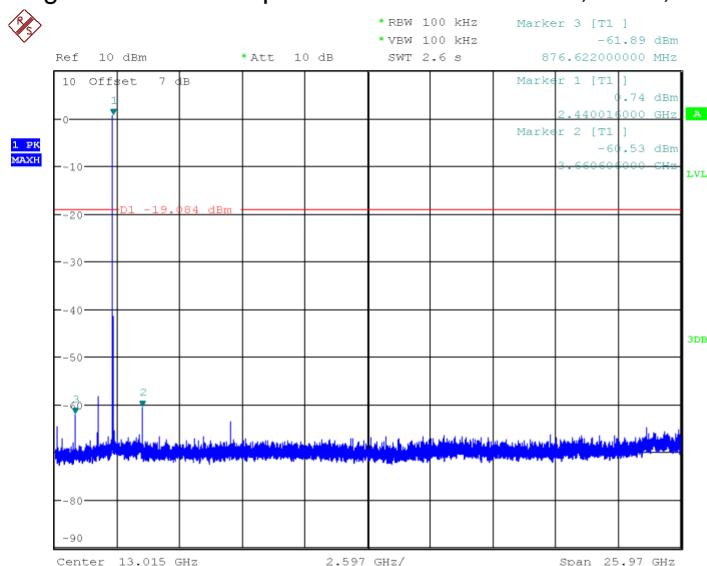
Fig.34 Conducted spurious emission: 8DPSK, Ch0, 2402MHz


Date: 5.MAY.2015 14:47:24

Fig.35 Conducted spurious emission: 8DPSK, Ch0, 30MHz~26GHz

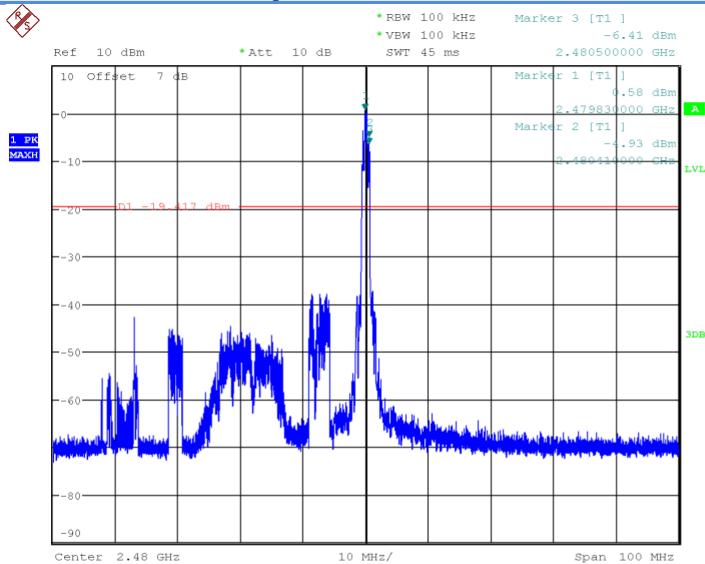


Date: 5.MAY.2015 14:47:49

Fig.36 Conducted spurious emission: 8DPSK, Ch39, 2441MHz


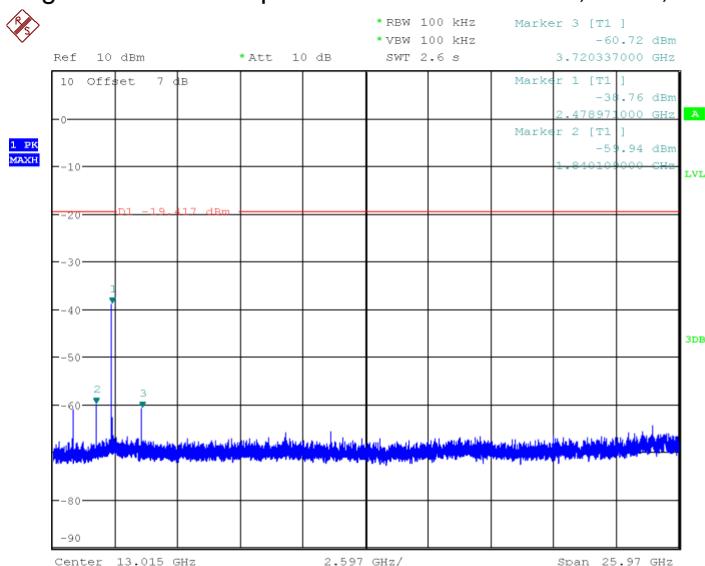
Date: 5.MAY.2015 14:48:12

Fig.37 Conducted spurious emission: 8DPSK, Ch39, 30MHz~26GHz



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Fig.38 Conducted spurious emission: 8DPSK, Ch78, 2480MHz



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Fig.39 Conducted spurious emission: 8DPSK, Ch78, 30MHz~26GHz

6.4 Radiated Emission

6.4.1 Measurement Limit:

Standard	Limit
FCC 47 CFR Part 15.247, 15.205, 15.209	20dB below peak output power

In addition, radiated emissions which fall in the restricted bands, as defined in 15.205(a),

must also comply with the radiated emission limits specified in 15.209(a) (see 15.205(c)).

And method please refer to ANSI 63.10 clause 6.5, 6.6.

Limit in restricted band:

Frequency of emission (MHz)	Field strength (uV/m)	Field strength (dBuV/m)
30~88	100	40
88~216	150	43.5
216~960	200	46
Above 960	500	54

6.4.2 Test Method

Portable, small, lightweight, or modular devices that may be handheld, worn on the body, or placed on a table during operation shall be positioned on a non-conducting platform, the top of which is 80 cm above the reference ground plane. The preferred area occupied by the EUT arrangement is 1 m by 1.5 m, but it may be larger or smaller to accommodate various sized EUTs. For testing purposes, ceiling- and wall-mounted devices also shall be positioned on a tabletop (see also ANSI C63.10-2009 section 6.3.4 and 6.3.5). In making any tests involving handheld, body-worn, or ceiling-mounted equipment, it is essential to recognize that the measured levels may be dependent on the orientation (attitude) of the three orthogonal axes of the EUT. Thus, exploratory tests as specified in 8.3.1 shall be carried out for various axes orientations to determine the attitude having maximum or near-maximum emission level.

The EUT was placed on a non-conductive table. The measurement antenna was placed at a distance of 3 meters from the EUT. During the tests, the antenna height and the EUT azimuth were varied in order to identify the maximum level of emissions from the EUT. This maximization process was repeated with the EUT positioned in each of its three orthogonal orientations.

Frequency of emission (MHz)	RBW/VBW	Sweep Time (s)
30~1000	100KHz/300KHz	5
1000~4000	1MHz/1MHz	15
4000~18000	1MHz/1MHz	40
18000~26500	1MHz/1MHz	20

Note: The position of EUT is 1.5m above the ground.

6.4.3 Measurement Results:

A “reference path loss” is established and A_{Rpi} is the attenuation of “reference path loss”, and including the gain of receive antenna , the gain of the preamplifier, the cable loss.

The measurement results are obtained as described below:



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A_{RPI} = Cable loss + Antenna Gain-Preamplifier gain

Result = $P_{Mea} + A_{RPI}$

For GFSK

Channel	Frequency Range	Test Results	Conclusion
Ch0 2402MHz	30MHz~1GHz	Fig.40	P
	1GHz~3GHz	Fig.41	P
	3GHz~18GHz	Fig.42	P
Power	2.38GHz~2.4GHz	Fig.43	P
Power	2.45GHz~2.5GHz	Fig.44	P
All channels	18GHz~26GHz	Fig.45	P

For $\pi/4$ DQPSK

Channel	Frequency Range	Test Results	Conclusion
Ch0 2402MHz	30MHz~1GHz	Fig.46	P
	1GHz~3GHz	Fig.47	P
	3GHz~18GHz	Fig.48	P
Power	2.38GHz~2.4GHz	Fig.49	P
Power	2.45GHz~2.5GHz	Fig.50	P
All channels	18GHz~26GHz	Fig.51	P

For 8DPSK

Channel	Frequency Range	Test Results	Conclusion
Ch0 2402MHz	30MHz~1GHz	Fig.52	P
	1GHz~3GHz	Fig.53	P
	3GHz~18GHz	Fig.54	P
Power	2.38GHz~2.4GHz	Fig.55	P
Power	2.45GHz~2.5GHz	Fig.56	P
All channels	18GHz~26GHz	Fig.57	P

GFSK Ch0 30MHz-1GHz

Frequency(MHz)	Result(dBuV/m)	ARPI (dB)	PMea(dBuV/m)	Polarity



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36.7808	28.4	-25.6	54	V
39.0388	34.82	-25.1	59.92	V
39.1607	34.16	-25.1	59.26	V
39.4152	34.55	-25	59.55	V
39.6095	34.77	-25	59.77	V
40.4379	35.45	-24.9	60.35	V

GFSK Ch0 1GHz-3GHz

Frequency(MHz)	Result(dBuV/m)	ARpl (dB)	PMea(dBuV/m)	Polarity
2752.9601	53.06	10.1	42.96	H
2809.3482	54.18	10.7	43.48	H
2854.5365	54.19	11.2	42.99	V
2911.7526	54.78	11.7	43.08	V
2965.1986	55.25	12.7	42.55	H
2999.3416	55.89	13.7	42.19	V

GFSK Ch0 3GHz-18GHz

Frequency(MHz)	Result(dBuV/m)	ARpl (dB)	PMea(dBuV/m)	Polarity
14155.8816	54.33	19.1	35.23	H
14894.775	56.41	22.1	34.31	H
15396.307	56.39	23.2	33.19	V

$\pi/4$ DQPSK Ch0 30MHz-1GHz

Frequency(MHz)	Result(dBuV/m)	ARpl (dB)	PMea(dBuV/m)	Polarity
34.2492	19.28	-26	45.28	V
37.3843	25.5	-25.4	50.9	V
38.8426	27.29	-25.1	52.39	V
40.3002	25.56	-24.9	50.46	V
42.2176	24.57	-24.9	49.47	V



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44.5155	23.2	-25	48.2	V
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π/4 DQPSK Ch0 1GHz-3GHz

Frequency(MHz)	Result(dBuV/m)	ARPI (dB)	PMea(dBuV/m)	Polarity
2667.2101	53.24	9.6	43.64	H
2712.2723	52.46	9.8	42.66	V
2756.92	53.71	10.1	43.61	V
2843.4717	54.01	10.1	43.91	V
2884.758	54.19	11.4	42.79	V
2988.7765	56.99	13.4	43.59	H

π/4 DQPSK Ch0 3GHz-18GHz

Frequency(MHz)	Result(dBuV/m)	ARPI (dB)	PMea(dBuV/m)	Polarity
13313.7581	52.8	17.3	35.5	V
14307.0031	54.94	20.7	34.24	H
14905.3085	57.07	22.2	34.87	V
15816.1102	57.82	24.7	33.12	V
16441.6627	58.48	24.7	33.78	H

8DPSK 30MHz-1GHz

Frequency(MHz)	Result(dBuV/m)	ARPI (dB)	PMea(dBuV/m)	Polarity
33.9756	15.03	-26	41.03	V
34.6621	16	-25.9	41.9	V
47.5475	11.79	-25	36.79	V
63.1111	4.51	-26.1	30.61	V
77.5779	6.43	-28.3	34.73	V
248.4085	10.29	-22.2	32.49	H

8DPSK 1GHz-3GHz

Frequency(MHz)	Result(dBuV/m)	ARPI (dB)	PMea(dBuV/m)	Polarity
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2812.5211	53.55	10.7	42.85	H
2867.6521	54.1	11.3	42.8	H
2911.1998	54.73	11.7	43.03	V
2923.5676	54.92	11.9	43.02	V
2972.9746	55.39	12.9	42.49	H
2992.9292	56.08	13.5	42.58	H

8DPSK 3GHz-18GHz

Frequency(MHz)	Result(dBuV/m)	ARpl (dB)	PMea(dBuV/m)	Polarity
15631.5418	56.97	23.2	33.77	H
16453.5986	58.63	26.3	32.33	H
16945.5423	60.55	27.1	33.45	H
17248.2344	60.73	27.5	33.23	H
17683.5883	61.73	28.7	33.03	H
17948.0265	63.09	28.7	34.39	H

All Ch 18GHz~26.5GHz

Frequency(MHz)	Result(dBuV/m)	ARpl (dB)	PMea(dBuV/m)	Polarity
19525.786000	49.0	6.97	42.03	V
20684.980000	47.7	6.97	40.73	H
22119.789000	45.3	3.05	42.05	V
23627.899000	43.8	3.05	40.75	H
24606.319000	43.4	3.05	40.35	V
25244.558000	43.6	3.05	40.55	H

Note: all the test data shown was peak detected.

Conclusion: PASS

Test graphs as below:

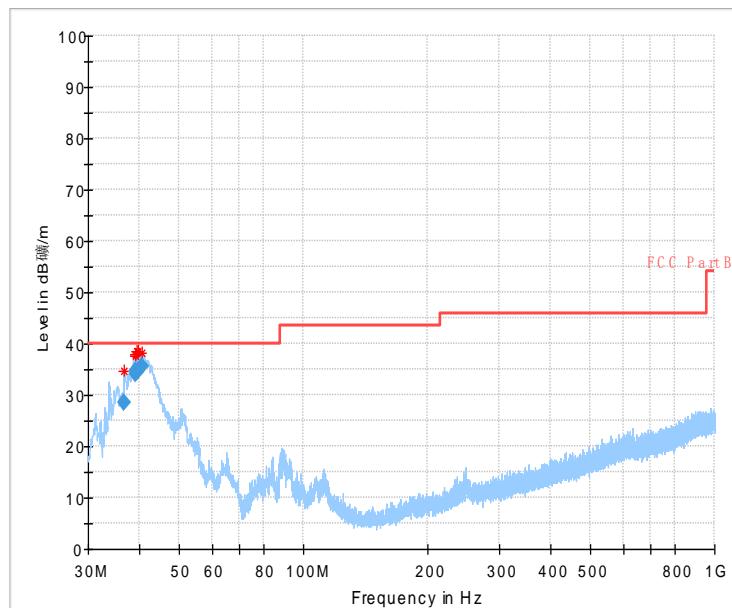


Fig.40 Radiated emission: GFSK, Ch0, 30MHz~1GHz

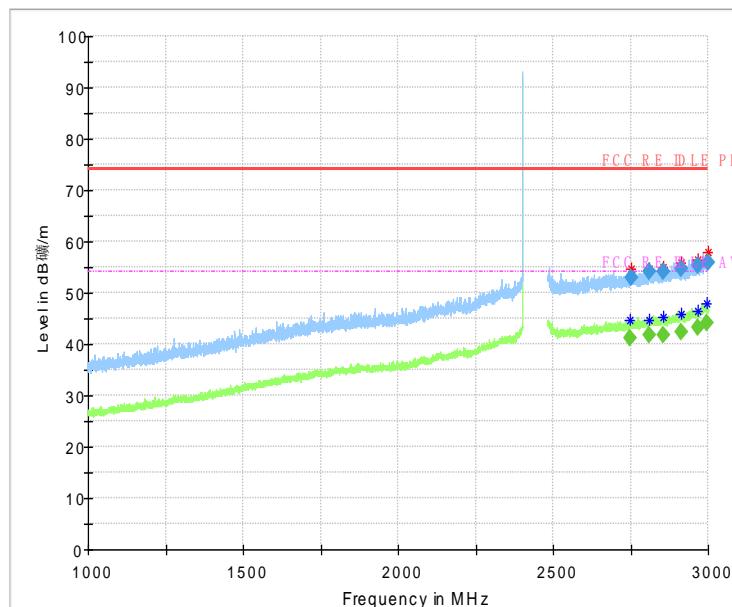


Fig.41 Radiated emission: GFSK, Ch0, 1GHz~3GHz

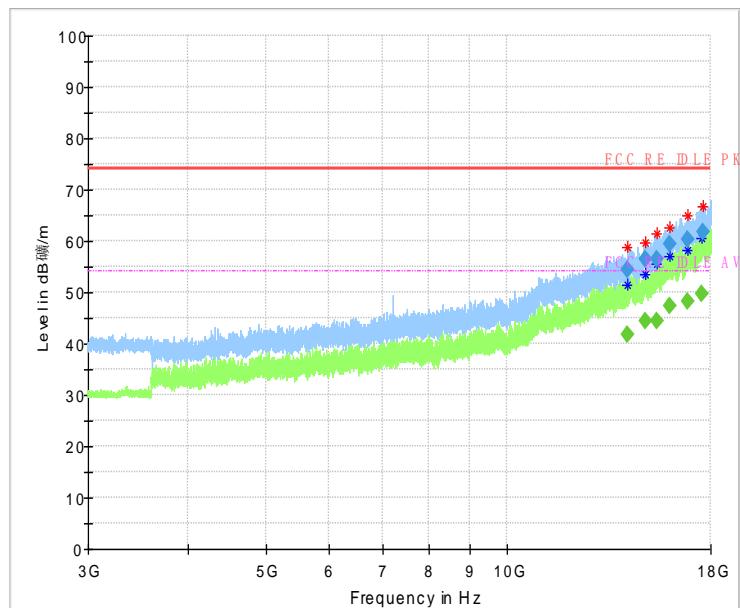


Fig.42 Radiated emission: GFSK, Ch0, 3GHz~18GHz

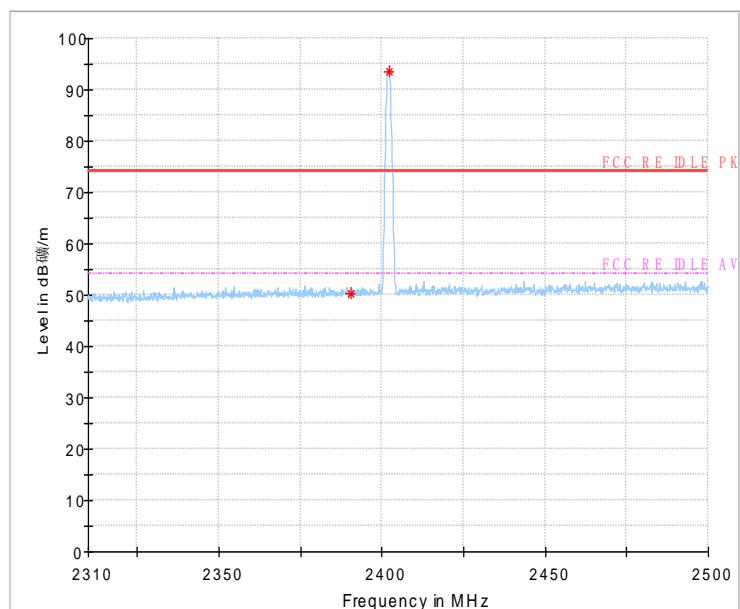


Fig.43 Radiated emission (Power): GFSK, low channel

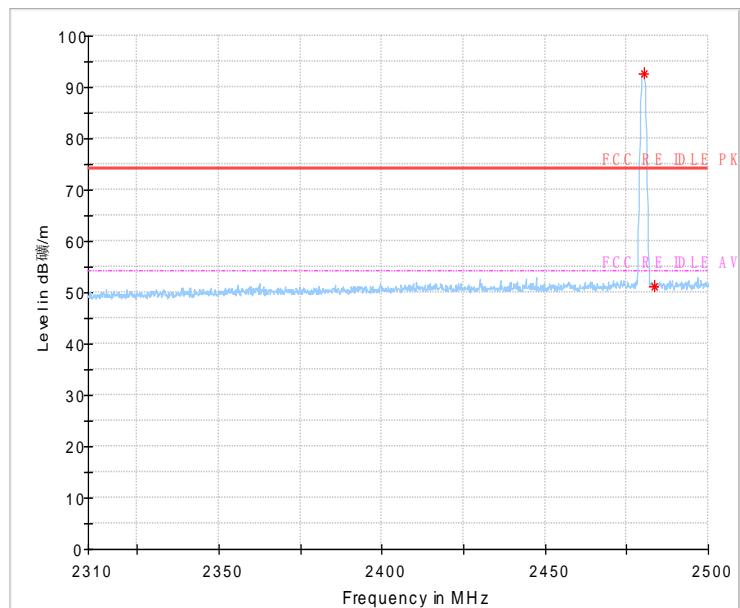


Fig.44 Radiated emission (Power): GFSK, high channel

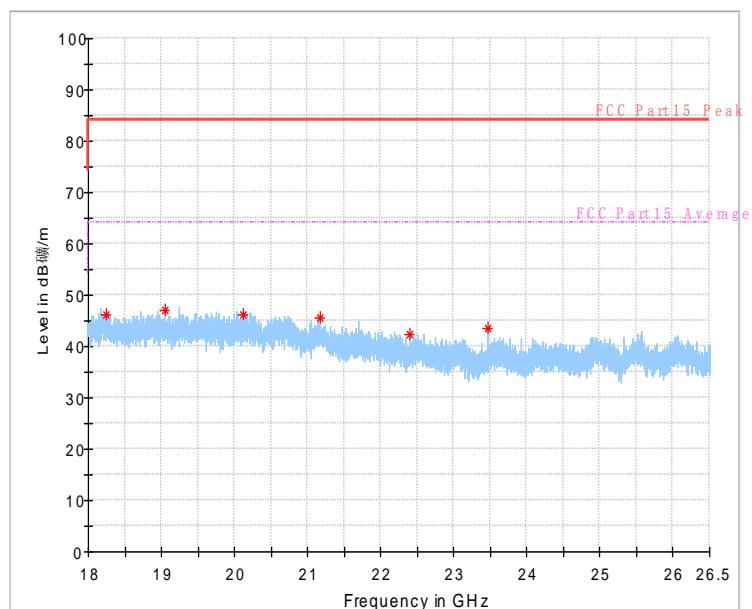


Fig.45 Radiated emission: GFSK, 18 GHz - 26 GHz

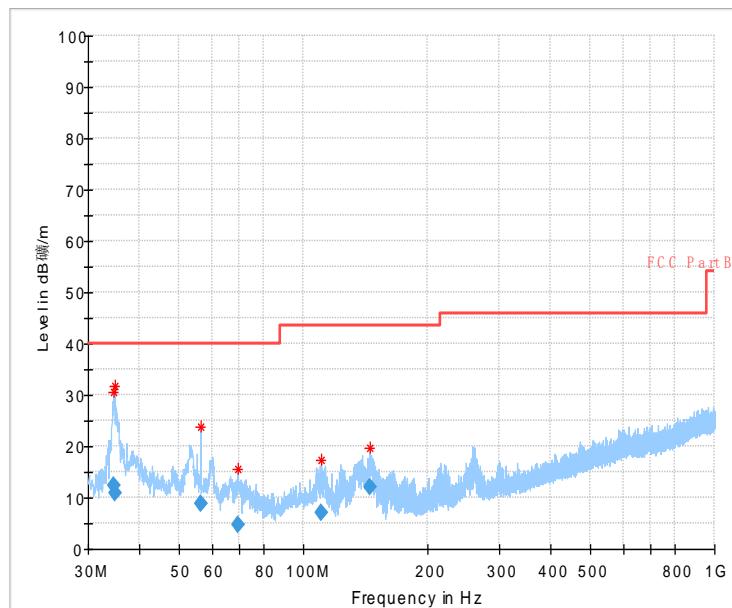


Fig.46 Radiated emission: $\pi/4$ DQPSK, Ch0, 30MHz~1GHz

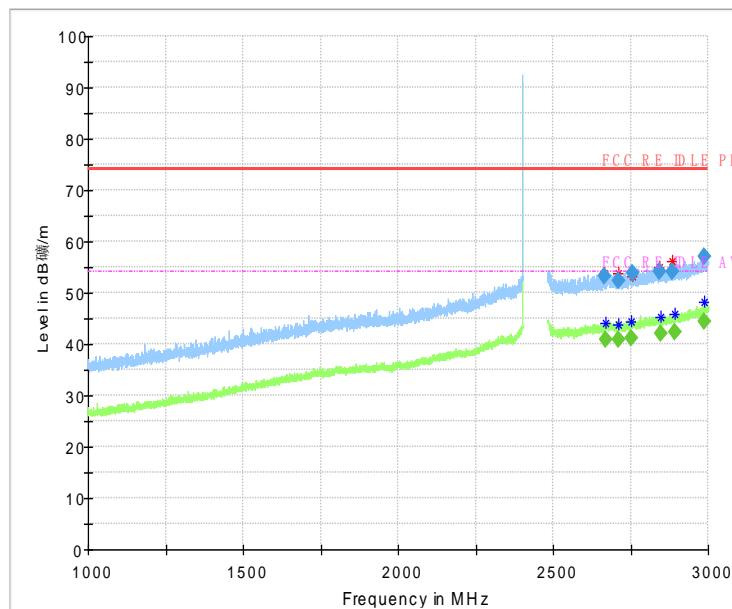


Fig.47 Radiated emission: $\pi/4$ DQPSK, Ch0, 1GHz~3GHz

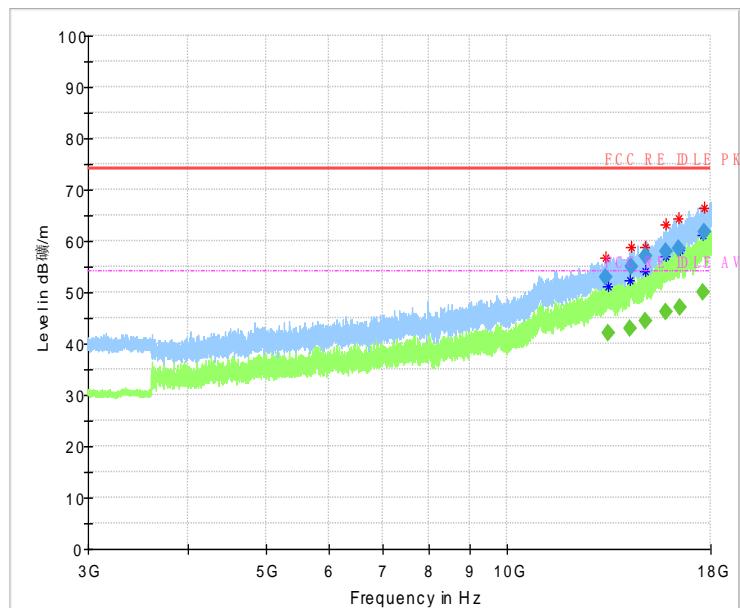


Fig.48 Radiated emission: $\pi/4$ DQPSK, Ch0, 3GHz~18GHz

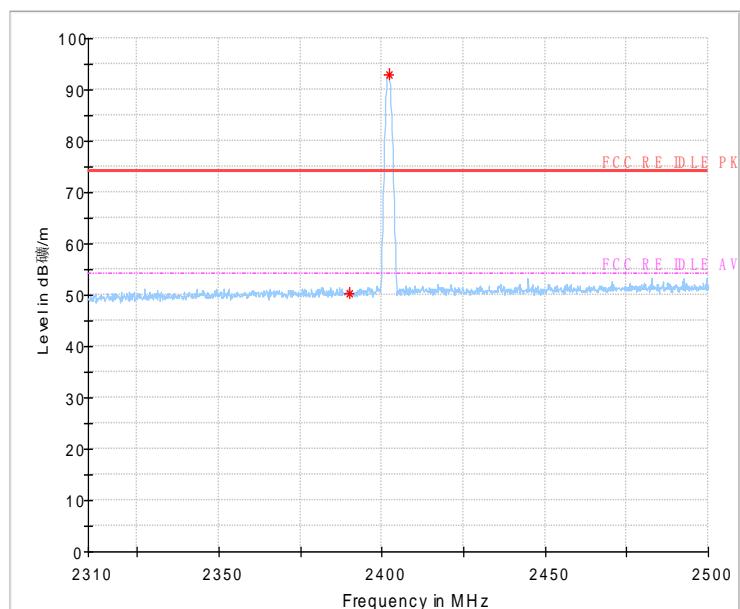


Fig.49 Radiated emission (Power): $\pi/4$ DQPSK, low channel

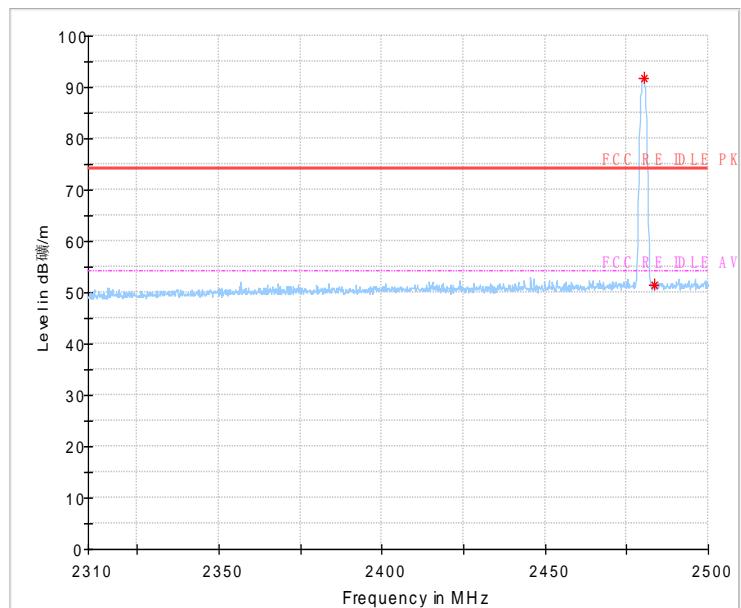


Fig.50 Radiated emission (Power): $\pi/4$ DQPSK, high channel

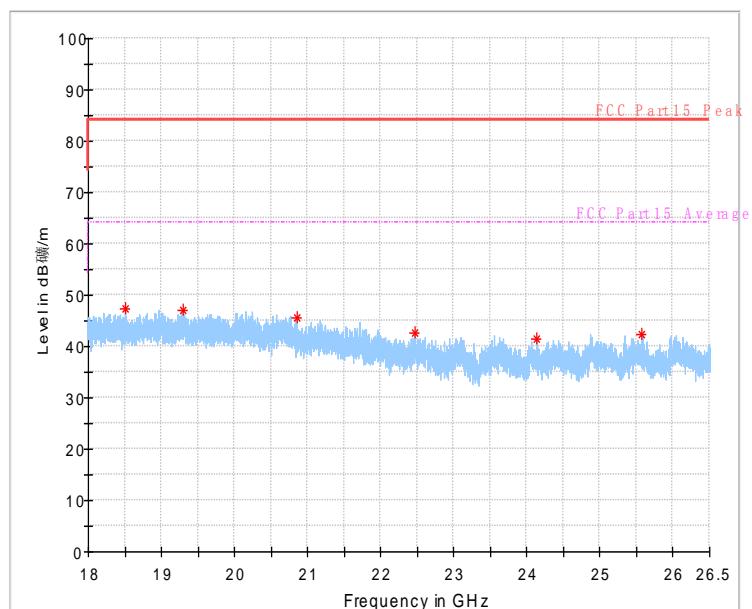


Fig.51 Radiated emission: $\pi/4$ DQPSK, 18 GHz - 26 GHz

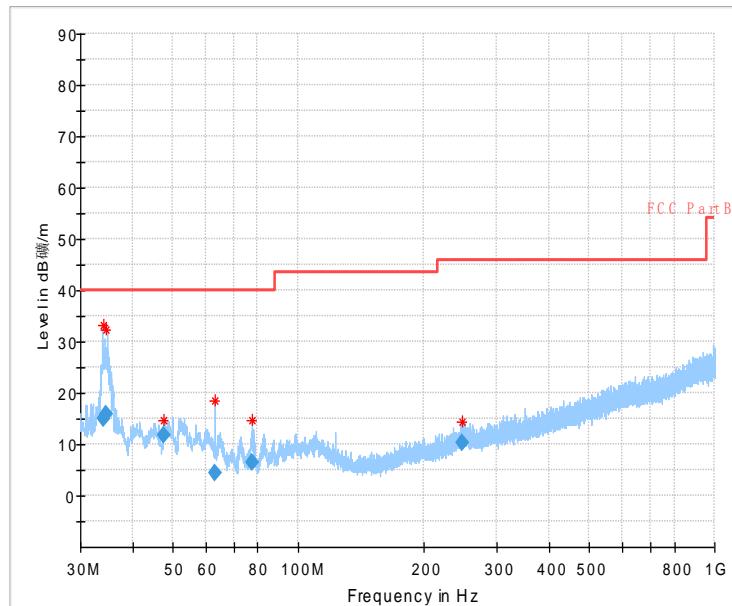


Fig.52 Radiated emission: 8DPSK, Ch0, 30MHz~1GHz

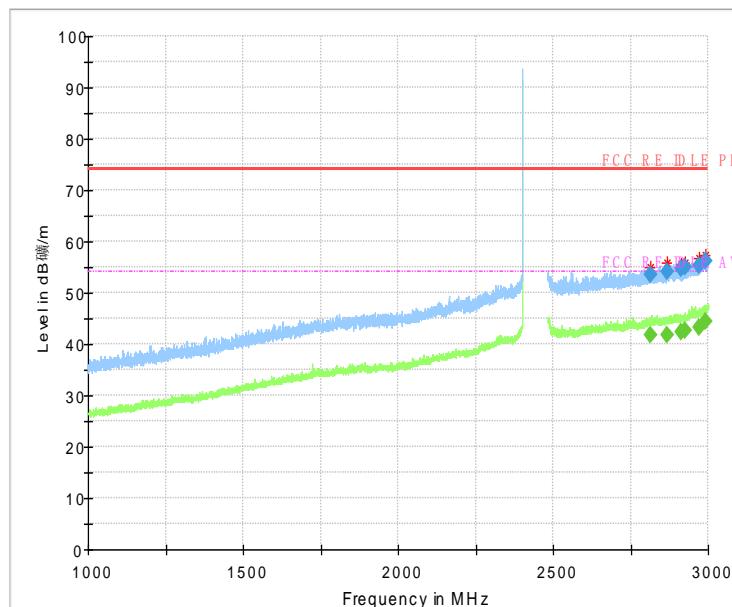


Fig.53 Radiated emission: 8DPSK, Ch0, 1GHz~3GHz

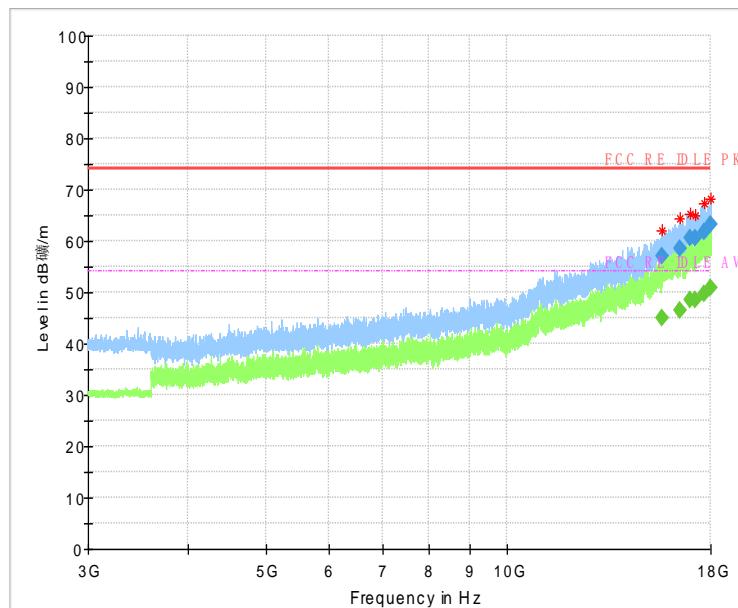


Fig.54 Radiated emission: 8DPSK, Ch0, 3GHz~18GHz

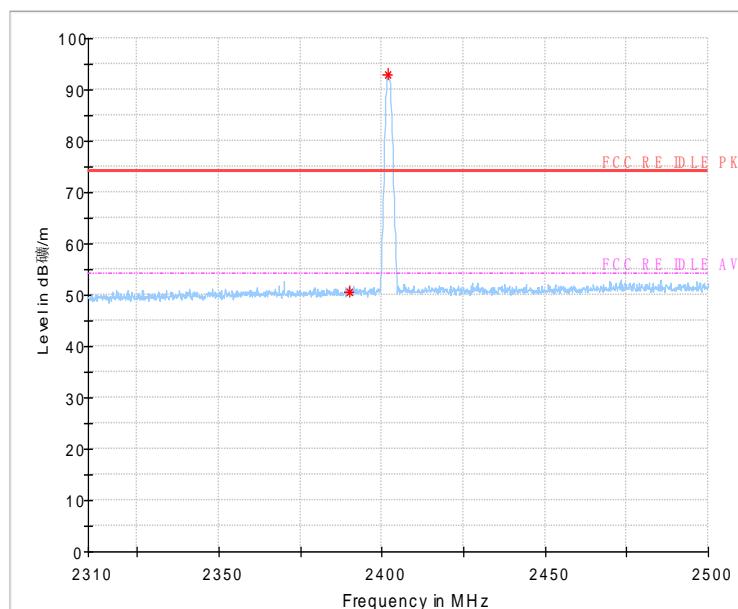


Fig.55 Radiated emission (Power): 8DPSK, low channel

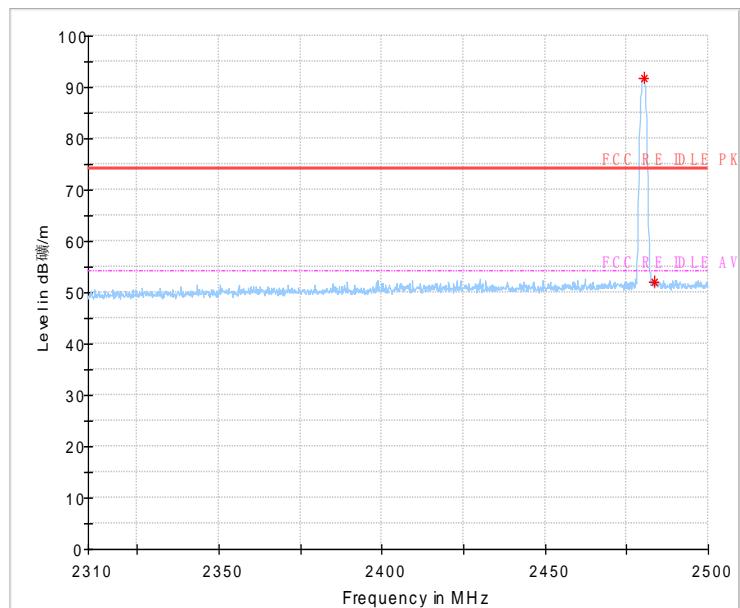


Fig.56 Radiated emission (Power): 8DPSK, high channel

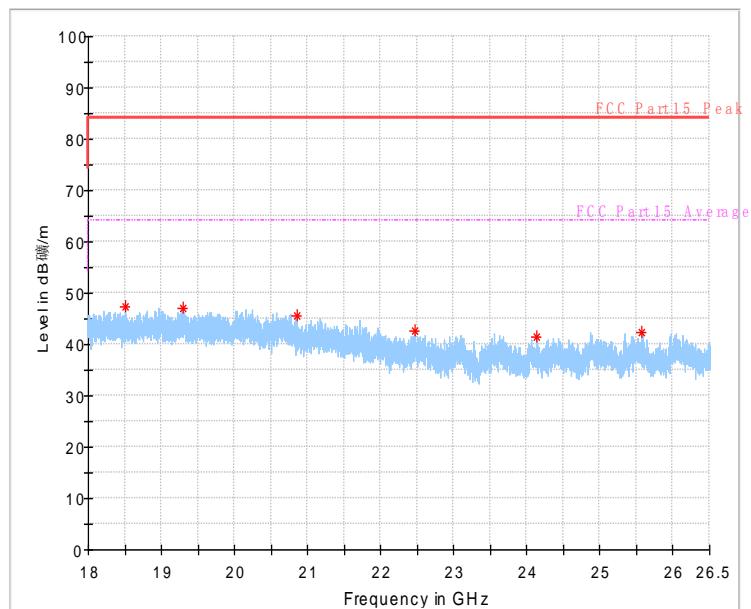


Fig.57 Radiated emission: 8DPSK, 18 GHz - 26 GHz

6.5 Time Of Occupancy (Dwell Time)

6.5.1 Measurement Limit:

Standard	Limit (ms)
FCC 47CFR Part 15.247 (a) (1) (iii)	< 400

6.5.2 Test procedures

The measurement is according to ANSI C63.10 clause 7.7.4

1. Connect the EUT through cable and divide with CBT32 and spectrum analyzer.
2. Enable the EUT transmit maximum power.
3. Set the spectrum analyzer as step 4 to step 8.
4. Span: Zero span, centered on a hopping channel.
5. RBW shall be \leq channel spacing and where possible RBW should be set $>> 1 / T$, where T is the expected dwell time per channel.
6. Sweep: As necessary to capture the entire dwell time per hopping channel; where possible use a video trigger and trigger delay so that the transmitted signal starts a little to the right of the start of the plot. The trigger level might need slight adjustment to prevent triggering when the system hops on an adjacent channel; a second plot might be needed with a longer sweep time to show two successive hops on a channel.
7. Detector function: Peak.
8. Trace: Max hold.
9. Use the marker-delta function, and record it.

6.5.3 Measurement Result

For GFSK

Channel	Packet	Dwell Time (ms)		Conclusion
39	DH1	Fig.58	161.089	P
		Fig.59		
	DH3	Fig.60	281.187	P
		Fig.61		
	DH5	Fig.62	319.519	P
		Fig.63		

For $\pi/4$ DQPSK

Channel	Packet	Dwell Time (ms)		Conclusion
39	2DH1	Fig.64	163.641	P
		Fig.65		
	2DH3	Fig.66	281.187	P
		Fig.67		
	2DH5	Fig.68	320.370	P
		Fig.69		

For 8DPSK

Channel	Packet	Dwell Time (ms)		Conclusion
39	3DH1	Fig.70	166.192	P
		Fig.71		
	3DH3	Fig.72	281.187	P
		Fig.73		
	3DH5	Fig.74	320.370	P
		Fig.75		

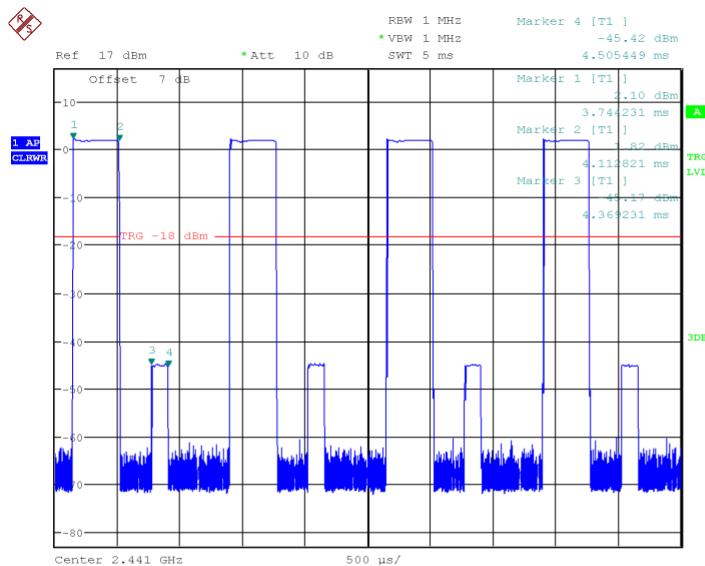
Note: the dwell time is Calculated of the sum of test time about 31.5 seconds.

Equation: dwell time = pusletime * (1600/N)/79*T . N is the number of timeslot; T is the time about 31.5s.

The time of DH5=3.005*(1600/6)/79*31.5=319.519ms.

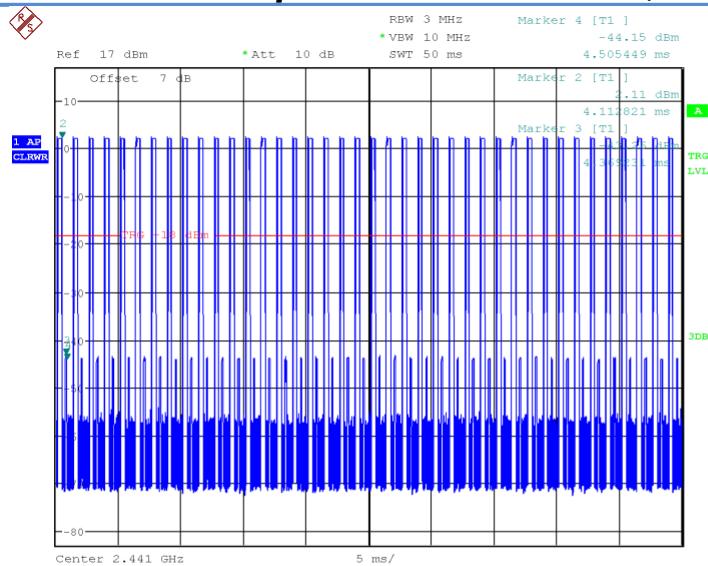
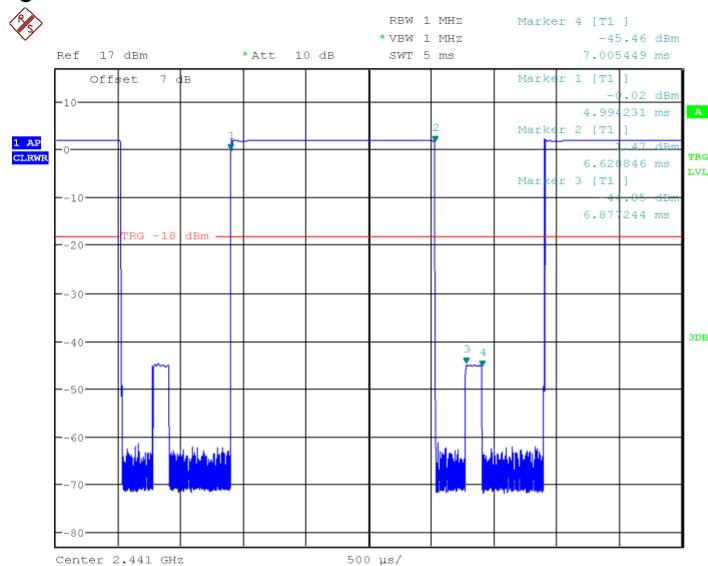
Conclusion: PASS

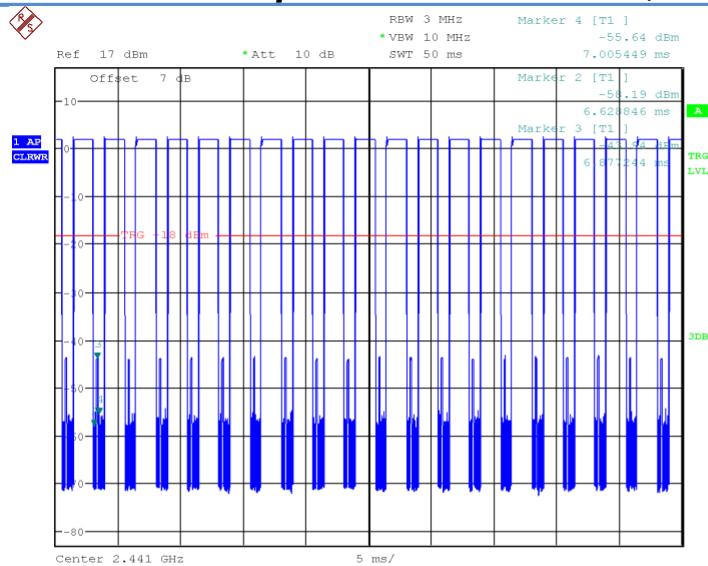
Test graphs as below:



Date: 5.MAY.2015 14:31:07

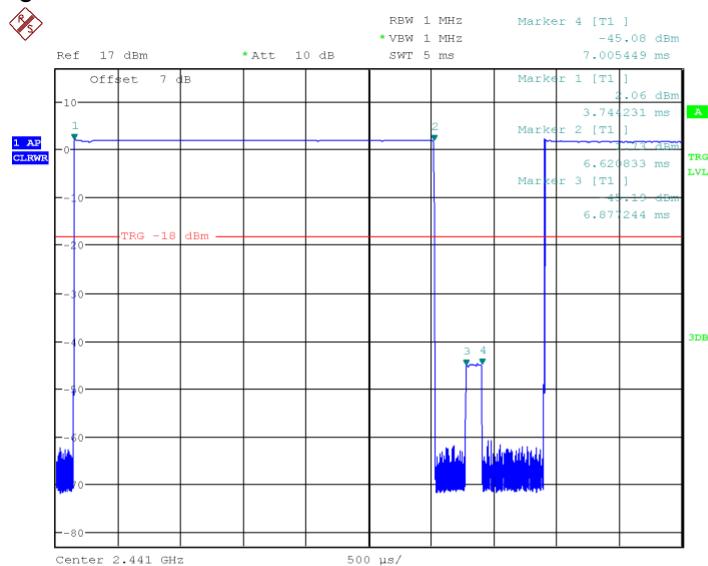
Fig.58 Time of occupancy (Dwell Time): Ch39, Packet DH1


Fig.59 Number of Transmissions Measurement: Ch39, Packet DH1

Fig.60 Time of occupancy (Dwell Time): Ch39, Packet DH3



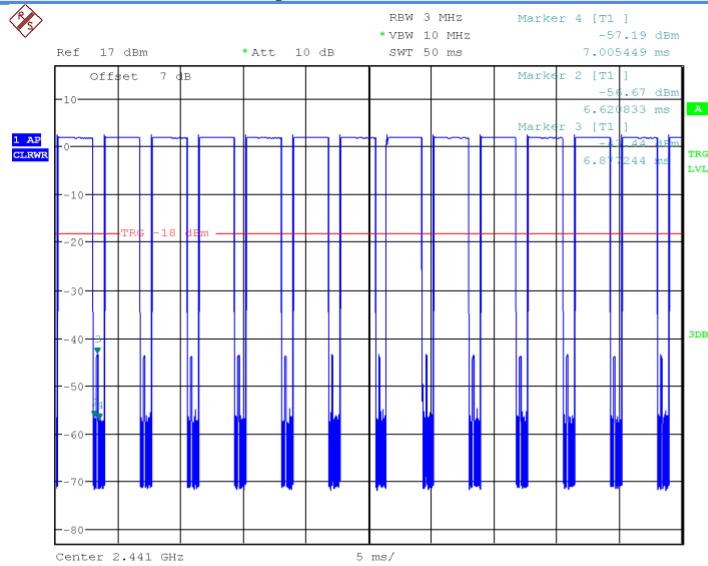
Date: 5.MAY.2015 14:31:31

Fig.61 Number of Transmissions Measurement: Ch39, Packet DH3



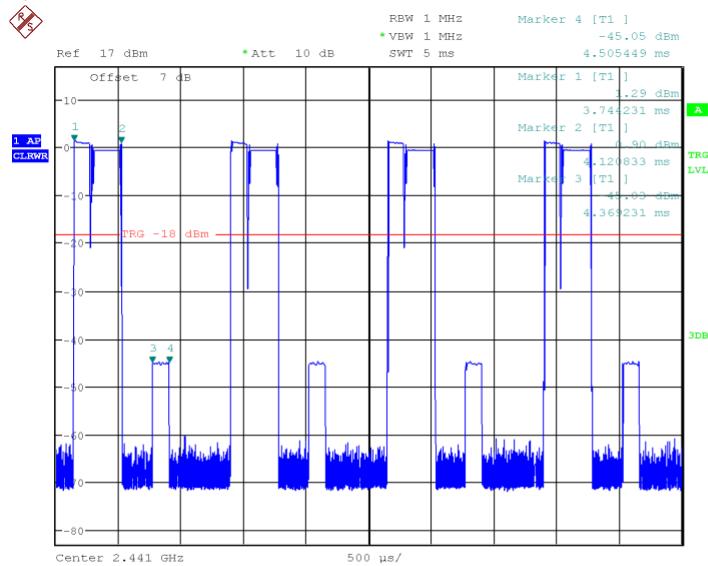
Date: 5.MAY.2015 14:31:40

Fig.62 Time of occupancy (Dwell Time): Ch39, Packet DH5



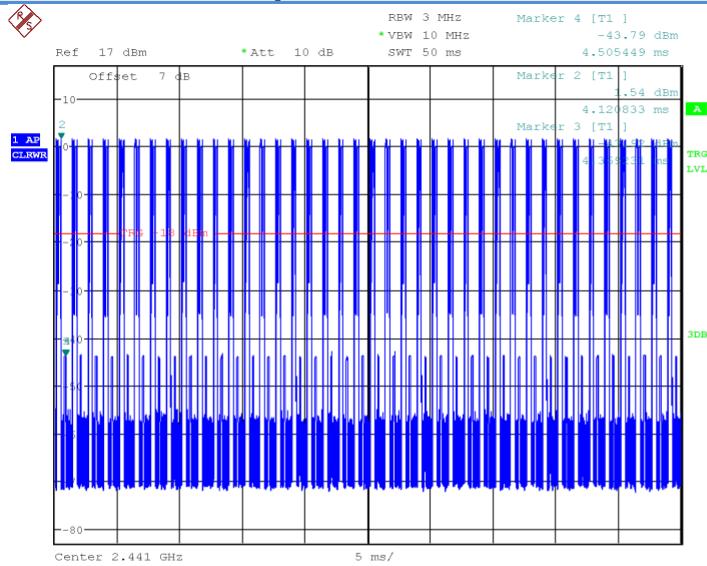
Date: 5.MAY.2015 14:31:47

Fig.63 Number of Transmissions Measurement: Ch39, Packet DH5

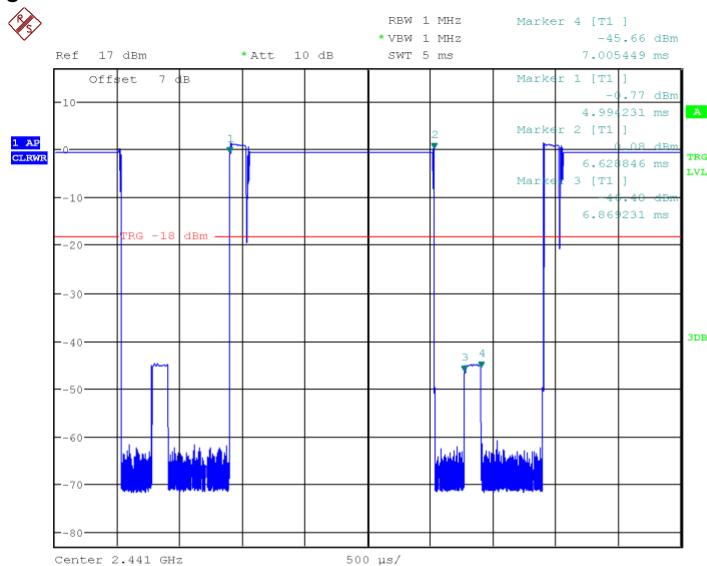


Date: 5.MAY.2015 14:31:56

Fig.64 Time of occupancy (Dwell Time): Ch39,Packet 2-DH1

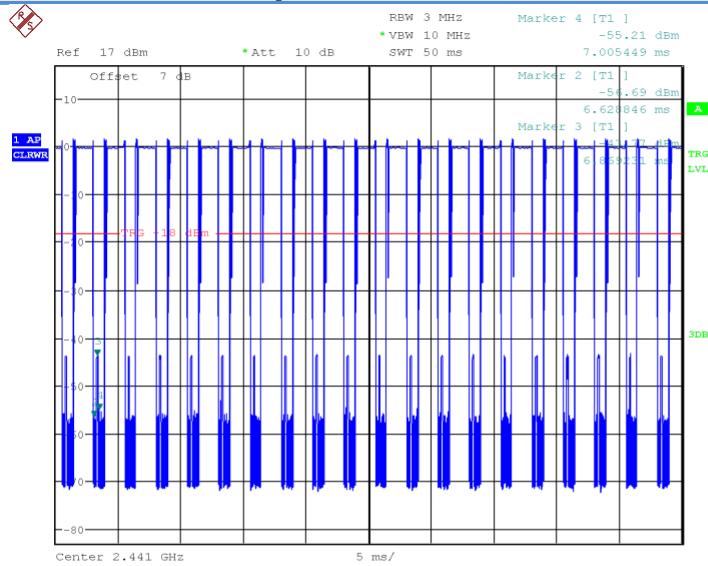


Date: 5.MAY.2015 14:32:04

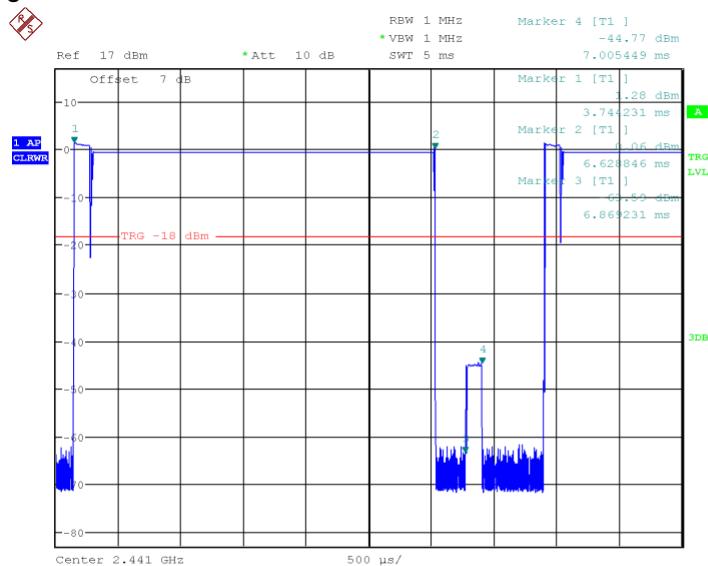
Fig.65 Number of Transmissions Measurement: Ch39, Packet 2-DH1


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Fig.66 Time of occupancy (Dwell Time): Ch39,Packet 2-DH3

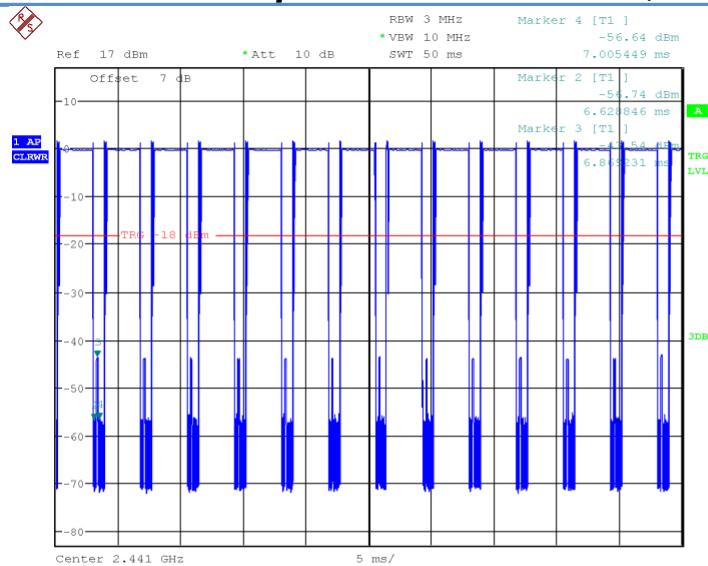


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Fig.67 Number of Transmissions Measurement: Ch39, Packet 2-DH3


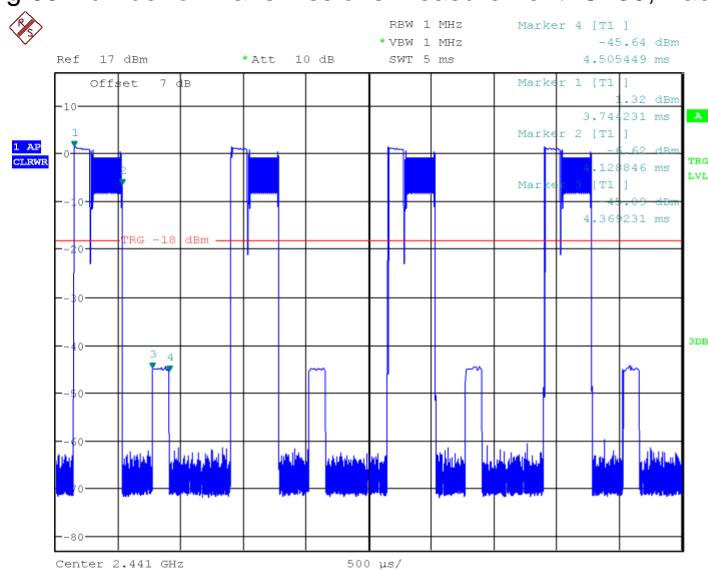
Date: 5.MAY.2015 14:32:30

Fig.68 Time of occupancy (Dwell Time): Ch39,Packet 2-DH5



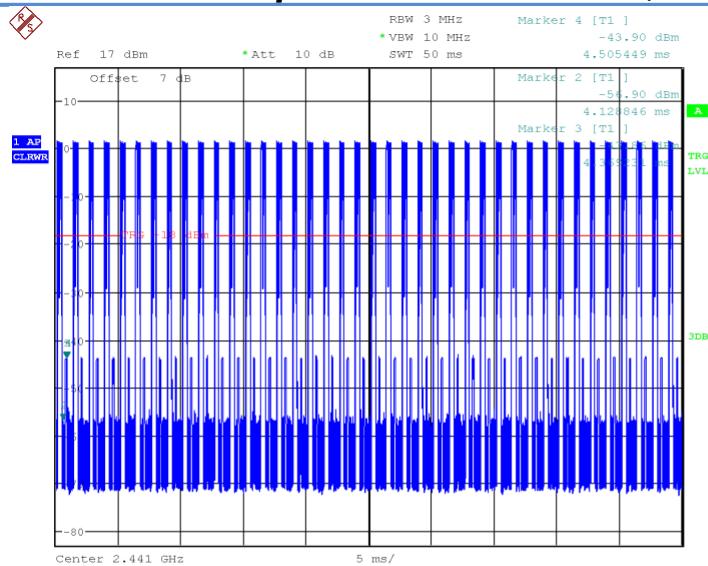
Date: 5.MAY.2015 14:32:37

Fig.69 Number of Transmissions Measurement: Ch39, Packet 2-DH5

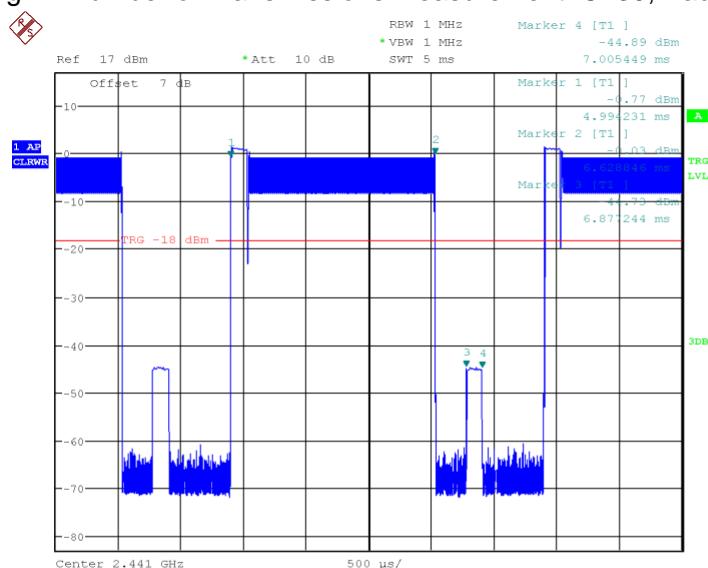


Date: 5.MAY.2015 14:32:46

Fig.70 Time of occupancy (Dwell Time): Ch39,Packet 3-DH1

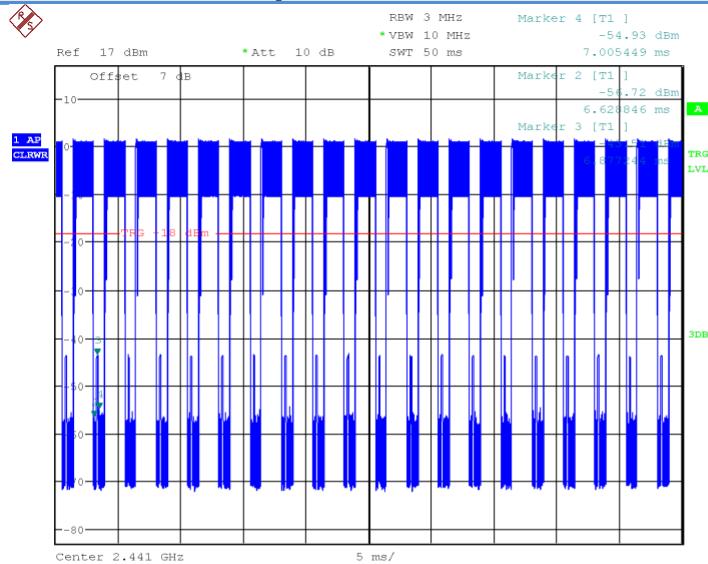


Date: 5.MAY.2015 14:32:54

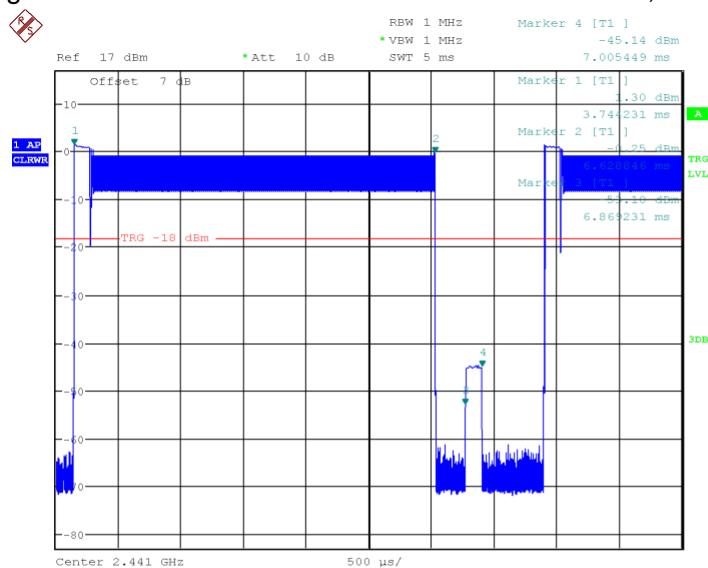
Fig.71 Number of Transmissions Measurement: Ch39, Packet 3-DH1


Date: 5.MAY.2015 14:33:03

Fig.72 Time of occupancy (Dwell Time): Ch39,Packet 3-DH3

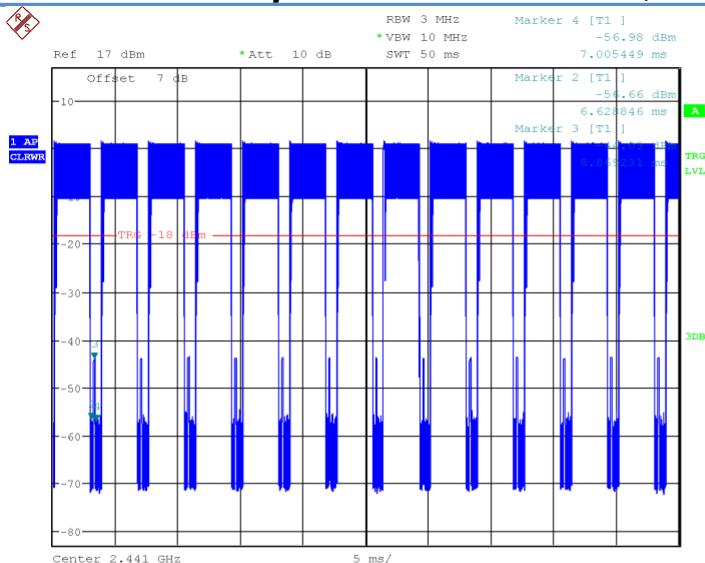


Date: 5.MAY.2015 14:33:10

Fig.73 Number of Transmissions Measurement: Ch39, Packet 3-DH3


Date: 5.MAY.2015 14:33:19

Fig.74 Time of occupancy (Dwell Time): Ch39,Packet 3-DH5



Date: 5.MAY.2015 14:33:27

Fig.75 Number of Transmissions Measurement: Ch39, Packet 3-DH5

6.6 20dB Bandwidth

6.6.1 Measurement Limit:

Standard	Limit
FCC 47 CFR Part 15.247 (a) (1)	N/A

6.6.2 Test procedures

The measurement is according to ANSI C63.10 clause 6.9.1.

1. Connect the EUT through cable and divide with CBT32 and spectrum analyzer.
2. Enable the EUT transmit maximum power.
3. Set the spectrum analyzer as
4. Span: two or five times of OBW
5. RBW= 1% to 5% of the OBW; VBW \geq 3RBW; Max Hold.
6. Select the max peak, and N DB DOWN=20dB.
7. Record the results.

Measurement Result:

For GFSK

Channel	20dB Bandwidth (MHz)		Conclusion
0	Fig.76	1.029	P
39	Fig.77	1.029	P

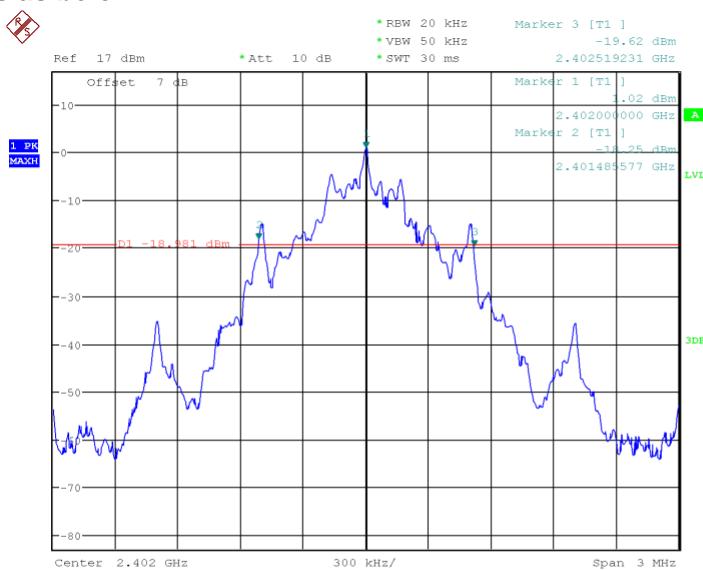
78	Fig.78	1.029	P
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For $\pi/4$ DQPSK

Channel	20dB Bandwidth (MHz)		Conclusion
0	Fig.79	1.091	P
39	Fig.80	1.091	P
78	Fig.81	1.091	P

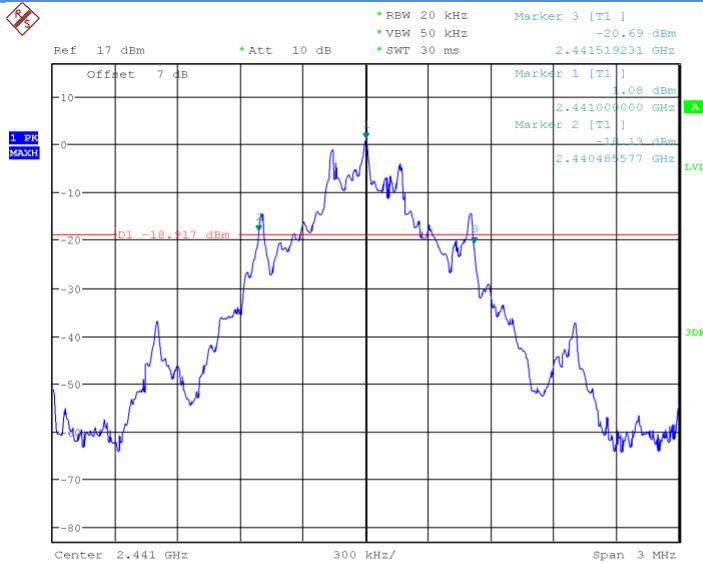
For 8DPSK

Channel	20dB Bandwidth (MHz)		Conclusion
0	Fig.82	1.192	P
39	Fig.83	1.192	P
78	Fig.84	1.192	P

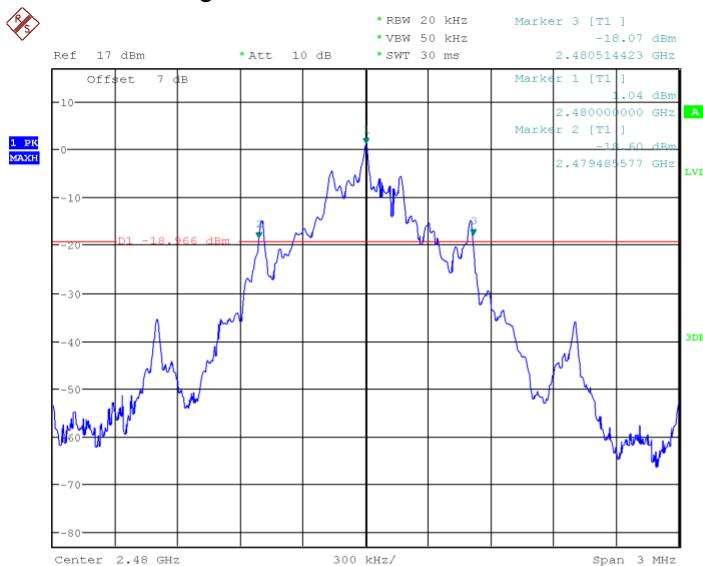
Conclusion: PASS
Test graphs as below:


Date: 24.APR.2015 16:15:49

Fig.76 20dB Bandwidth: GFSK, Ch0

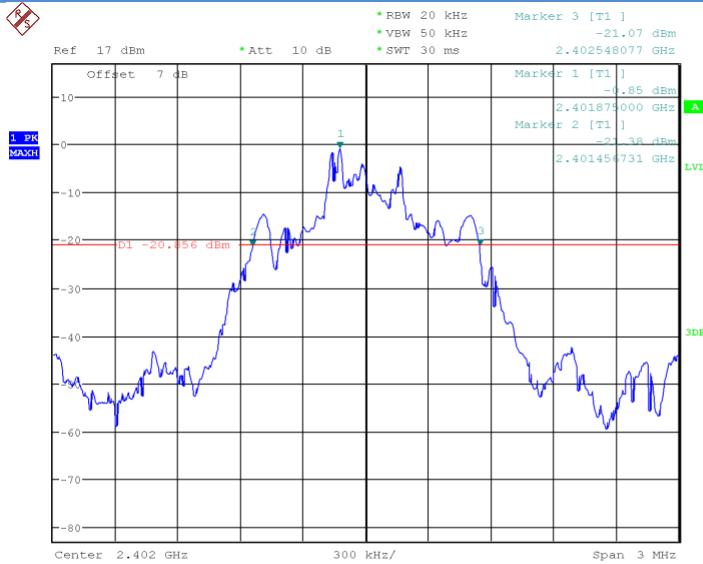


Date: 24.APR.2015 16:16:03

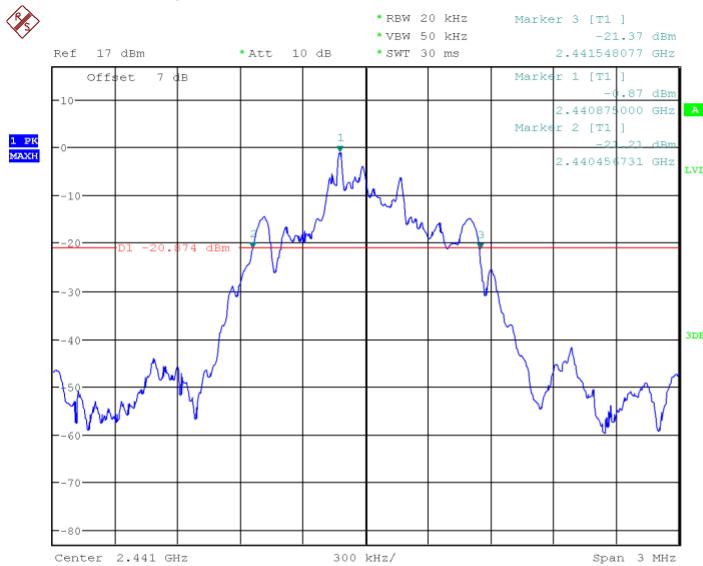
Fig.77 20dB Bandwidth: GFSK, Ch33


Date: 24.APR.2015 16:16:18

Fig.78 20dB Bandwidth: GFSK, Ch78

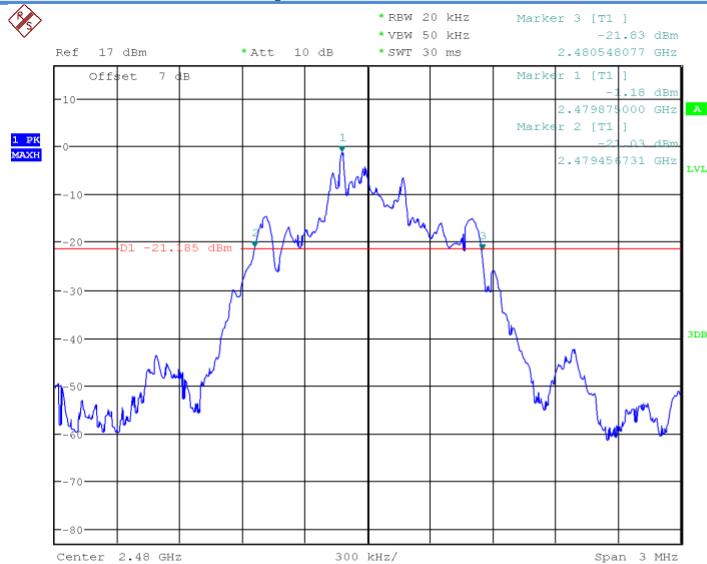


Date: 24.APR.2015 16:16:32

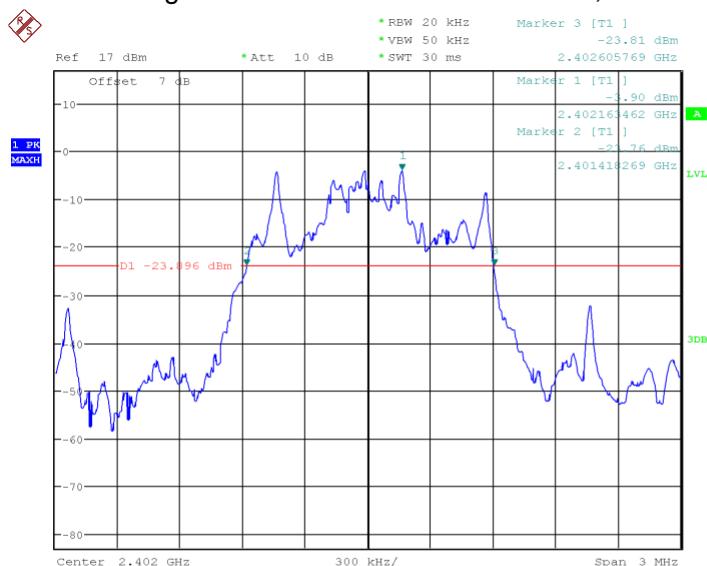
Fig.79 20dB Bandwidth: $\pi/4$ DQPSK, Ch0


Date: 24.APR.2015 16:16:46

Fig.80 20dB Bandwidth: $\pi/4$ DQPSK, Ch39

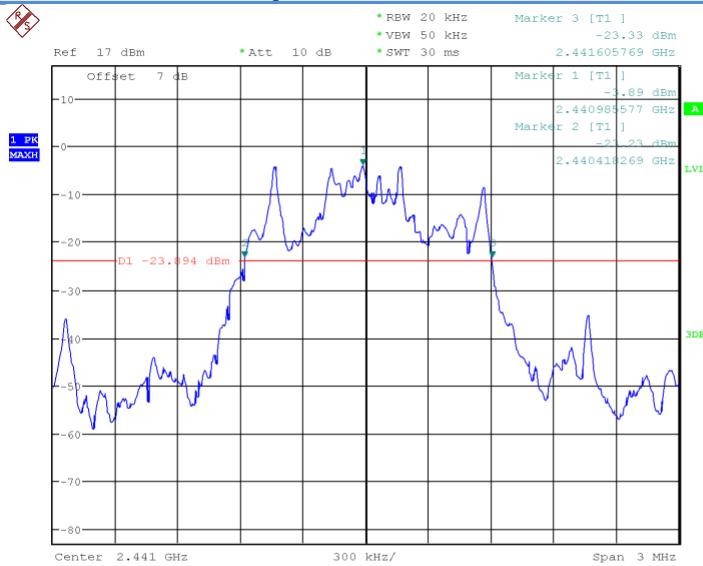


Date: 24.APR.2015 16:17:01

Fig.81 20dB Bandwidth: $\pi/4$ DQPSK, Ch78


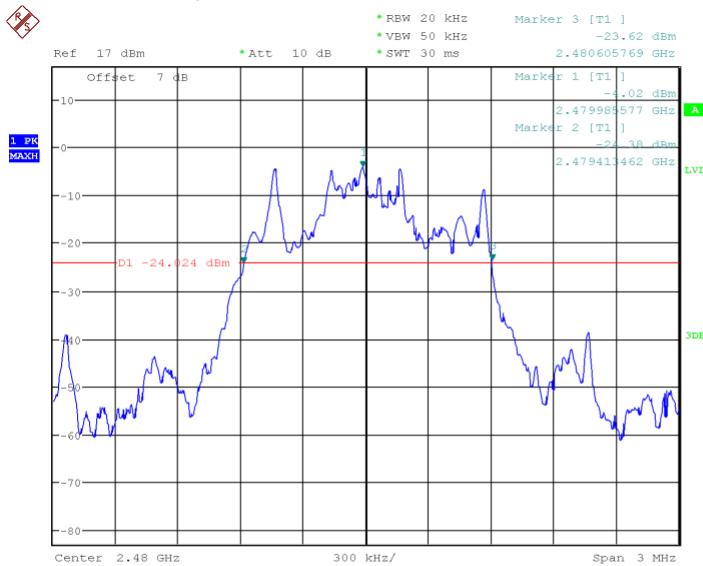
Date: 24.APR.2015 16:17:15

Fig.82 20dB Bandwidth: 8DPSK, Ch0



Date: 24.APR.2015 16:17:29

Fig.83 20dB Bandwidth: 8DPSK, Ch39



Date: 24.APR.2015 16:17:43

Fig.84 20dB Bandwidth: 8DPSK, Ch78

6.7 Carrier Frequency Separation

6.7.1 Measurement Limit:

Standard	Limit (KHz)
FCC 47 CFR Part 15.247 (a) (1)	Over 25KHz or $(2/3) * 20$ dB bandwidth

6.7.2 Test procedures

The measurement is according to ANSI C63.10 clause 7.7.2.

1. Connect the EUT through cable and divide with CBT32 and spectrum analyzer.
2. Enable the EUT transmit in hopping mode.
3. Span: Wide enough to capture the peaks of two adjacent channels.
4. RBW: Start with the RBW set to approximately 30% of the channel spacing; adjust as necessary to best identify the center of each individual channel.
5. Video (or average) bandwidth (VBW) \geq RBW.
6. Sweep: Auto.
7. Detector function: Peak.
8. Trace: Max hold.
9. Allow the trace to stabilize.

6.7.3 Measurement Result:

For GFSK

Channel	Carrier separation (KHz)		Conclusion
39	Fig.85	1000	P

For π/4 DQPSK

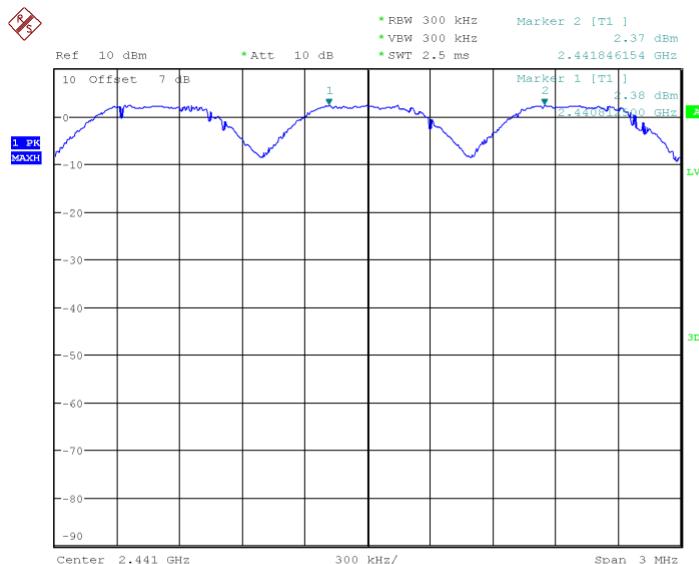
Channel	Carrier separation (KHz)		Conclusion
39	Fig.86	995.5769	P

For 8DPSK

Channel	Carrier separation (KHz)		Conclusion
39	Fig.87	1004.8077	P

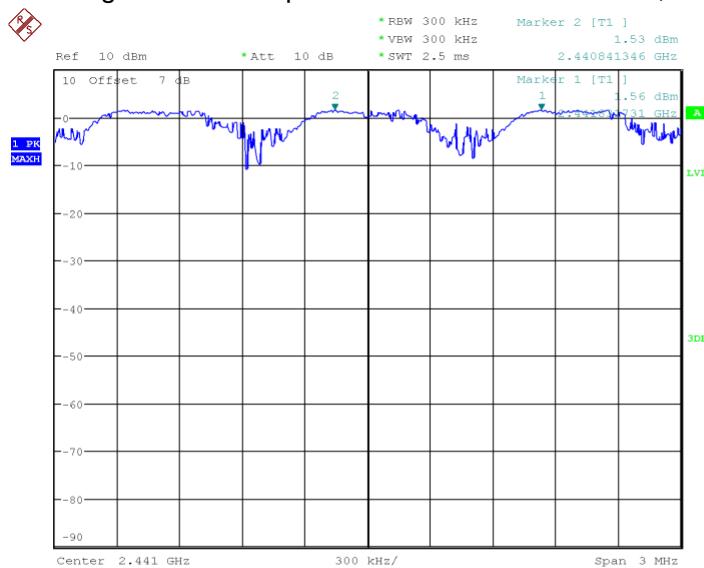
Conclusion: PASS

Test graphs as below:



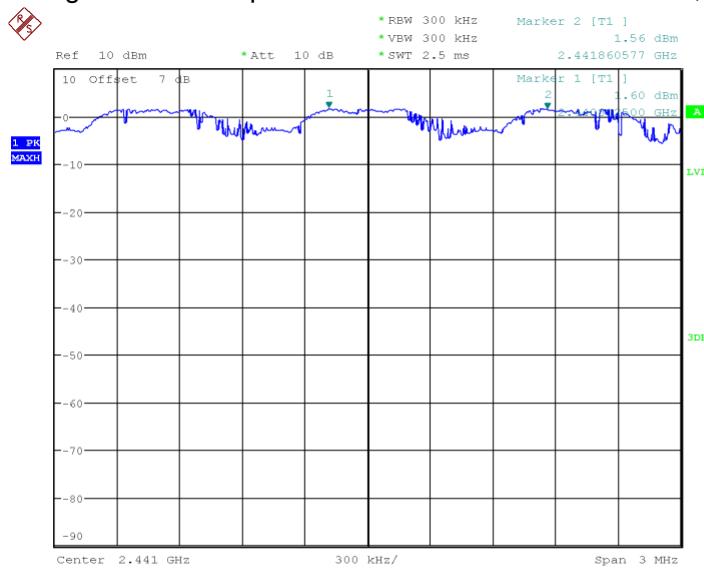
Date: 5.MAY.2015 14:50:41

Fig.85 Carrier separation measurement: GFSK, Ch39



Date: 5.MAY.2015 14:51:52

Fig.86 Carrier separation measurement: π/4 DQPSK, Ch39



Date: 5.MAY.2015 14:53:03

Fig.87 Carrier separation measurement: 8DPSK, Ch39

6.8 Number Of Hopping Channels

6.8.1 Measurement Limit:

Standard	Limit
FCC 47 CFR Part 15.247 (a)(1)(iii)	At least 15 non-overlapping channels

6.8.2 Test procedure

The measurement is according to ANSI C63.10 clause 7.7.3.

1. Connect the EUT through cable and divide with CBT32 and spectrum analyzer.
2. Enable the EUT transmit in hopping mode.
3. Span: The frequency band of operation. Depending on the number of channels the device supports, it may be necessary to divide the frequency range of operation across multiple spans, to allow the individual channels to be clearly seen.
4. RBW: To identify clearly the individual channels, set the RBW to less than 30% of the channel spacing or the 20 dB bandwidth, whichever is smaller.
5. VBW \geq RBW.
6. Sweep: Auto.
7. Detector function: Peak.
8. Trace: Max hold.
9. Allow the trace to stabilize.
10. Record the test results.

6.8.3 Measurement Result:**For GFSK**

Channel	Number of hopping channels		Conclusion
0~39	Fig.88	79	P
40~78	Fig.89		P

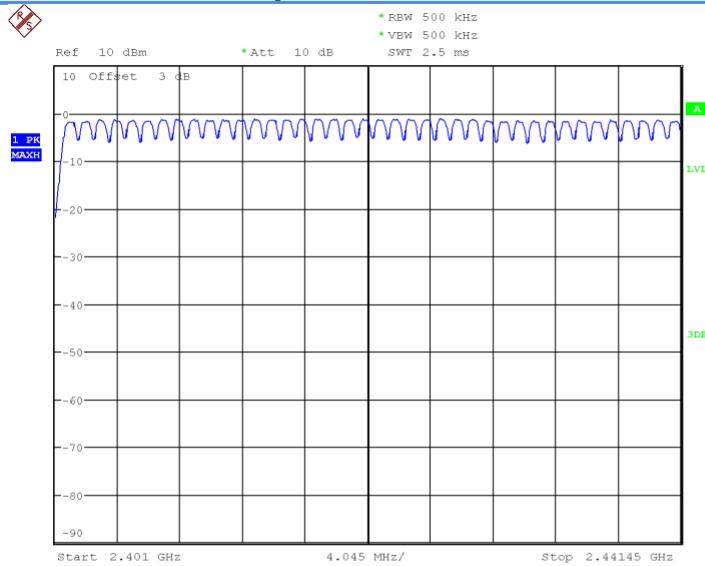
For $\pi/4$ DQPSK

Channel	Number of hopping channels		Conclusion
0~39	Fig.90	79	P
40~78	Fig.91		P

For 8DPSK

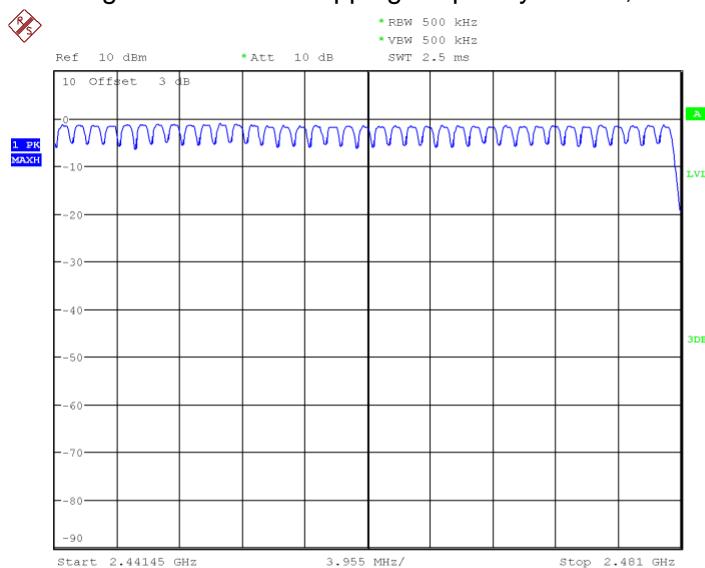
Channel	Number of hopping channels		Conclusion
0~39	Fig.92	79	P
40~78	Fig.93		P

Conclusion: PASS**Test graphs as below:**



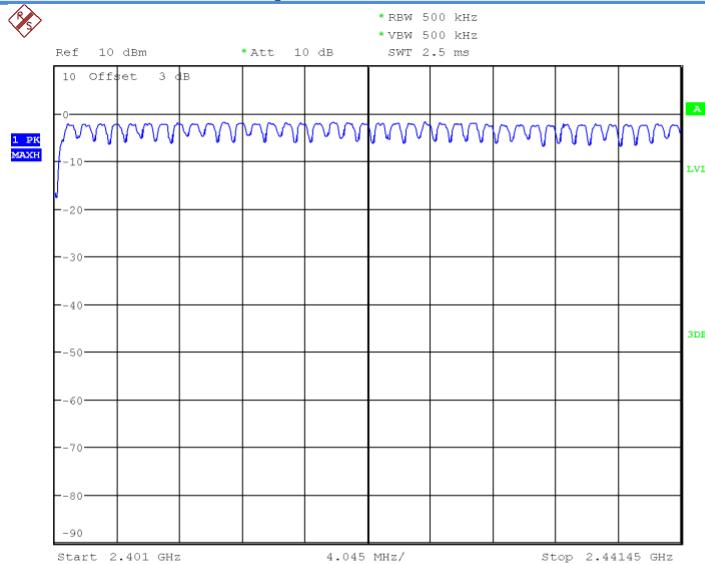
Date: 5.MAY.2015 14:55:38

Fig.88 Number of hopping frequency: GFSK, Ch0~39



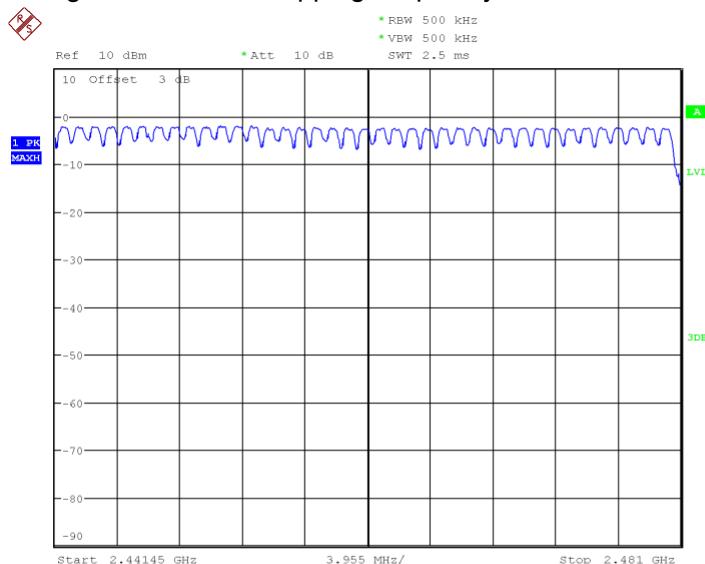
Date: 5.MAY.2015 14:57:42

Fig.89 Number of hopping frequency: GFSK, Ch40~78



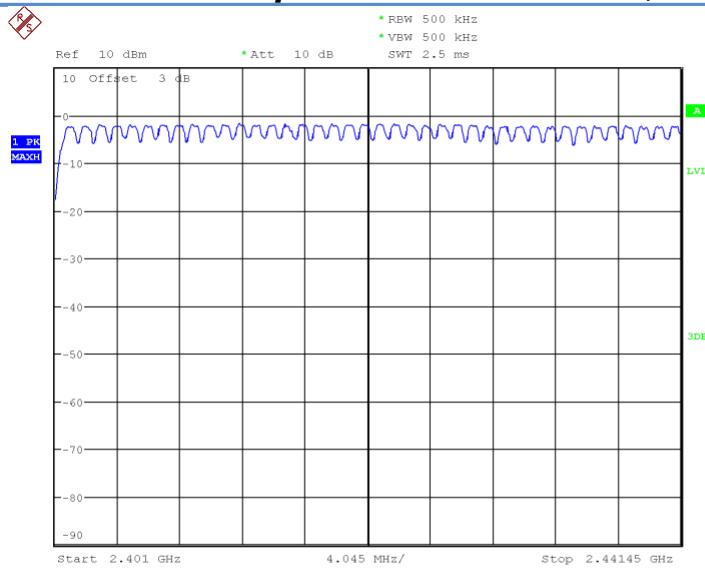
Date: 5.MAY.2015 14:59:48

Fig.90 Number of hopping frequency: $\pi/4$ DQPSK, Ch0~39

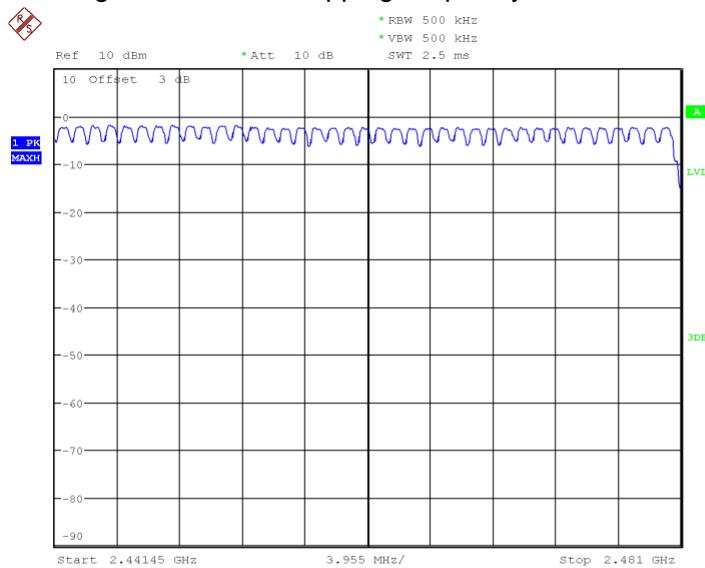


Date: 5.MAY.2015 15:01:53

Fig.91 Number of hopping frequency: $\pi/4$ DQPSK, Ch40~78



Date: 5.MAY.2015 15:03:58

Fig.92 Number of hopping frequency: 8DPSK, Ch0~39


Date: 5.MAY.2015 15:06:03

Fig.93 Number of hopping frequency: 8DPSK, Ch40~78

7 Test Equipments and Ancillaries Used For Tests

The test equipments and ancillaries used are as follows.

Conducted test system

No.	Equipment	Model	Serial Number	Manufacturer	Calibration Due date
1	Vector Signal Analyzer	FSQ26	101096	Rohde&Schwarz	2015-07-06
2	DC Power Supply	ZUP60-14	LOC-220Z006	TDL-Lambda	2015-07-06
3	Bluetooth Tester	CBT32	100785	Rohde&Schwarz	2016-01-06

Radiated emission test system

No.	Equipment	Model	Serial Number	Manufacturer	Calibration Due date
1	Universal Radio Communication Tester	CMU200	123101	R&S	2015-07-05
3	Test Receiver	ESU40	100307	R&S	2015-07-24
4	Trilog Antenna	VULB9163	19-162515	Schwarzbeck	2017-11-04
5	Double Ridged Guide Antenna	ETS-3117	135885	ETS	2017-05-05
8	2-Line V-Network	ENV216	101380	R&S	2015-07-24

Anechoic chamber

Fully anechoic chamber by Frankonia German.

8 Test Environment

Shielding Room1 (6.0 meters×3.0 meters×2.7 meters) did not exceed following limits along the conducted RF performance testing:

Temperature	Min. = 15 °C, Max. = 30 °C
Relative humidity	Min. = 30 %, Max. = 60 %
Shielding effectiveness	> 110 dB
Ground system resistance	< 0.5 Ω
Uniformity of field strength	Between 0 and 6 dB, from 80MHz to 3000 MHz

Control room did not exceed following limits along the EMC testing:

Temperature	Min. = 15 °C, Max. = 35 °C
Relative humidity	Min. = 30 %, Max. = 60 %
Shielding effectiveness	> 110 dB
Electrical insulation	> 10 kΩ
Ground system resistance	< 0.5 Ω

Fully-anechoic chamber1 (6.8 meters×3.08 meters×3.53 meters) did not exceed following limits along the EMC testing:

Temperature	Min. = 15 °C, Max. = 30 °C
Relative humidity	Min. = 30 %, Max. = 60 %
Shielding effectiveness	> 110 dB
Electrical insulation	> 10 kΩ
Ground system resistance	< 0.5 Ω
Uniformity of field strength	Between 0 and 6 dB, from 80MHz to 3000 MHz

Fully-anechoic chamber2 (Tapered Section: 8.75 meters×3.66 meters×3.66 meters, Rectangular Section: 7.32 meters×3.97 meters×3.66 meters) did not exceed following limits along the EMC testing:

Temperature	Min. = 15 °C, Max. = 30 °C
Relative humidity	Min. = 35 %, Max. = 60 %



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Shielding effectiveness	> 110 dB
Electrical insulation	> 10 kΩ
Ground system resistance	< 0.5 Ω
Uniformity of field strength	Between 0 and 6 dB, from 30MHz to 40000MHz

ANNEX A. Deviations from Prescribed Test Methods

No deviation from Prescribed Test Methods.

*****End The Report*****